

# A Brief Introduction to XAFS

focusing on the fundamental concepts and methods  
for those who will start XAFS experiments



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# Outline

- What is XAFS?
- How do we measure “lengths”?
- Things XAFS spectra give us
- Fundamental concepts & Basic equation of XAFS
- How to carry out XAFS measurements
  - Transmission mode
  - Fluorescence mode
- Some topics

# What is XAFS?

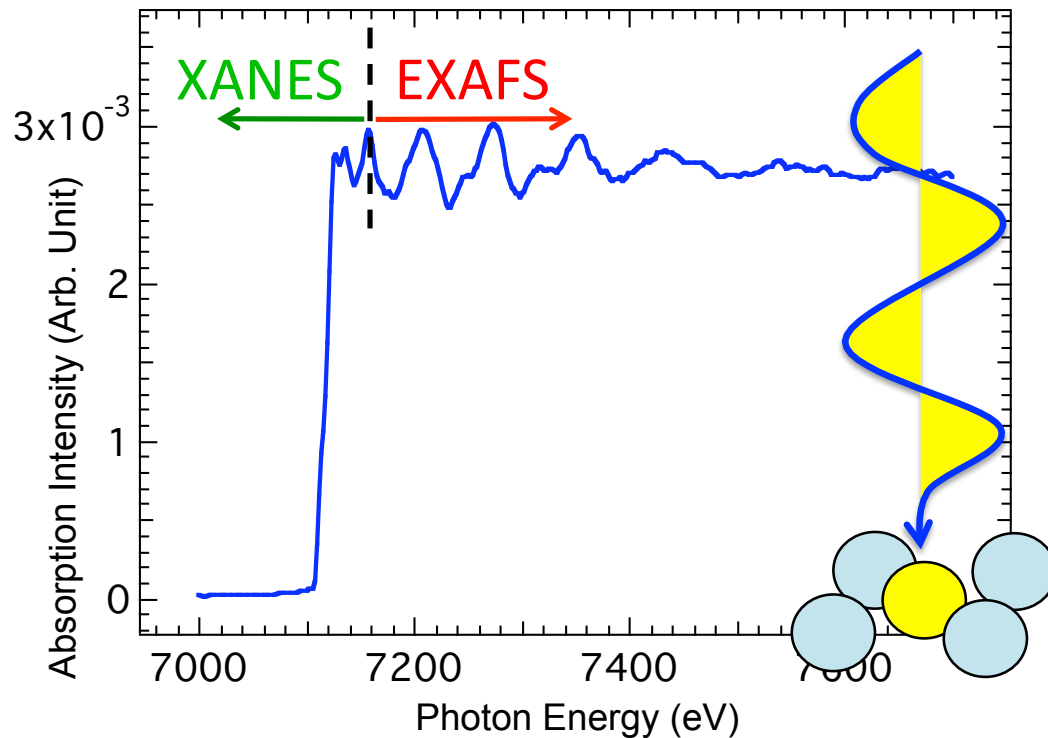
XAFS: **X**-ray **A**bsorption **F**ine **S**tructure

electronic state  
(valence)  
Symmetry

Bond length

Number of surrounding atoms (Coordination number)

Distribution, Thermal vibration



**Element specific**

to observe **Local structure**

(long range periodicity is not required)

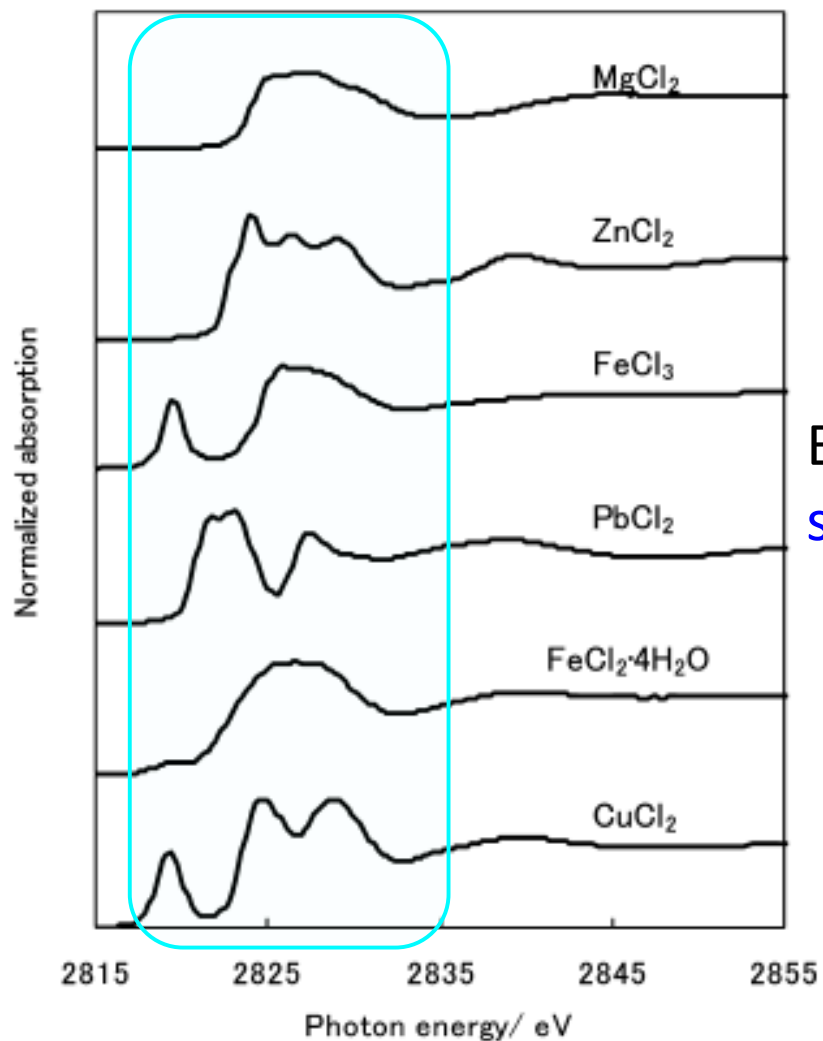
Solid, Liquid, Gas, whatever

XANES: X-ray Absorption Near Edge Structure

EXAFS: Extended X-ray Absorption Fine Structure

# XANES tells us what your sample is.

Cl K-edge XANES



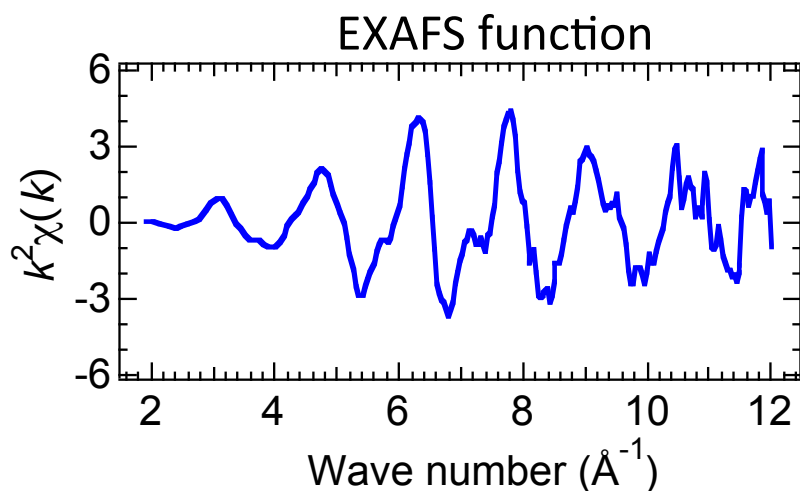
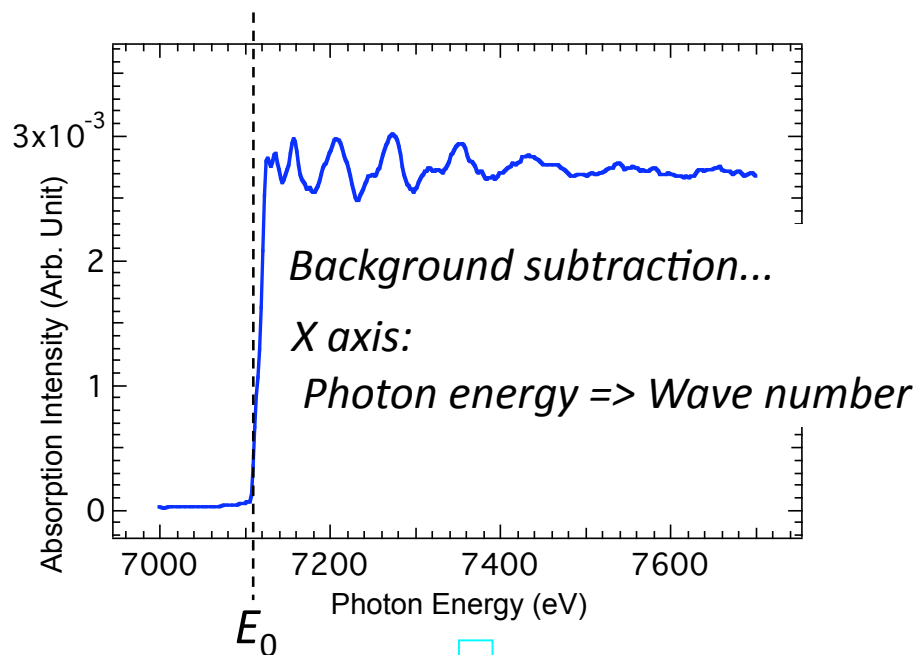
All these are metal chlorides.

But you can see some **specific features** in each spectrum.

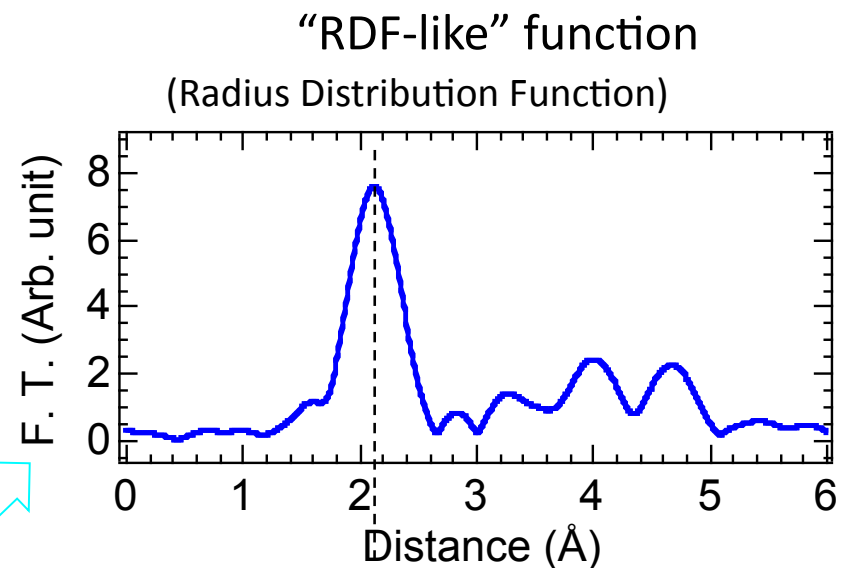
So you would recognize **what your sample is**.



# How to Obtain Bond Length by EXAFS



Fourier Transform



Nearest neighbor atomic distance  
+ phase shift

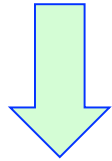
Bond length

Peak area

Coordination number

# How do we measure lengths?

***What** would you use when you measure a length of something?*



**Ruler:** with graduations, easy to measure the length

*OK, if you don't have a ruler, what would you do?*

You can use your **hand, arm or height** as a standard of length.

Proper standard “ruler” for a certain thing to be measured

(We never measure the length of pens with our heights.)

Things to be measured: Periodicity of crystal, bond length, ...

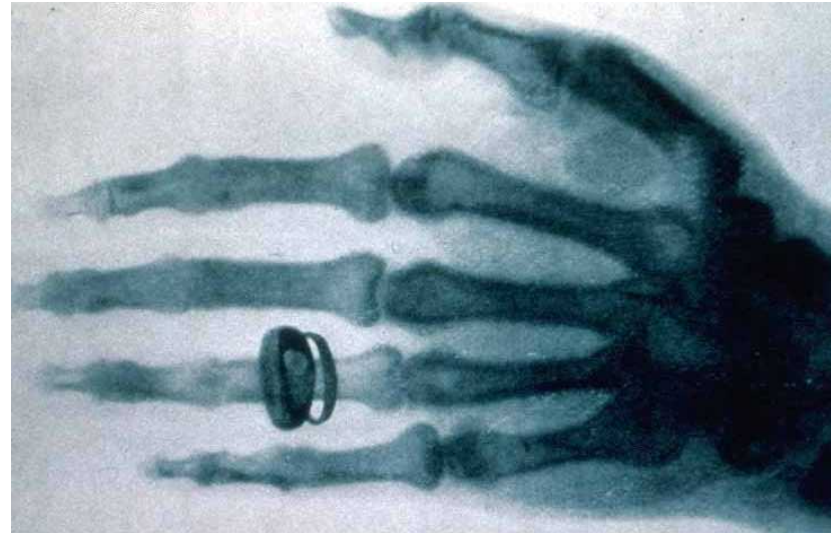
Proper standard “ruler”: **Wave length of x-ray, Wave property of electron,...**

# Discovery of x-ray

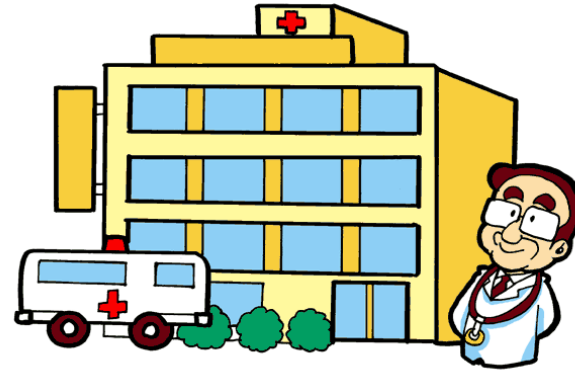


W. C. Röntgen (1845-1923)

1901, the 1<sup>st</sup> Nobel prize in Physics for discovery of x-ray



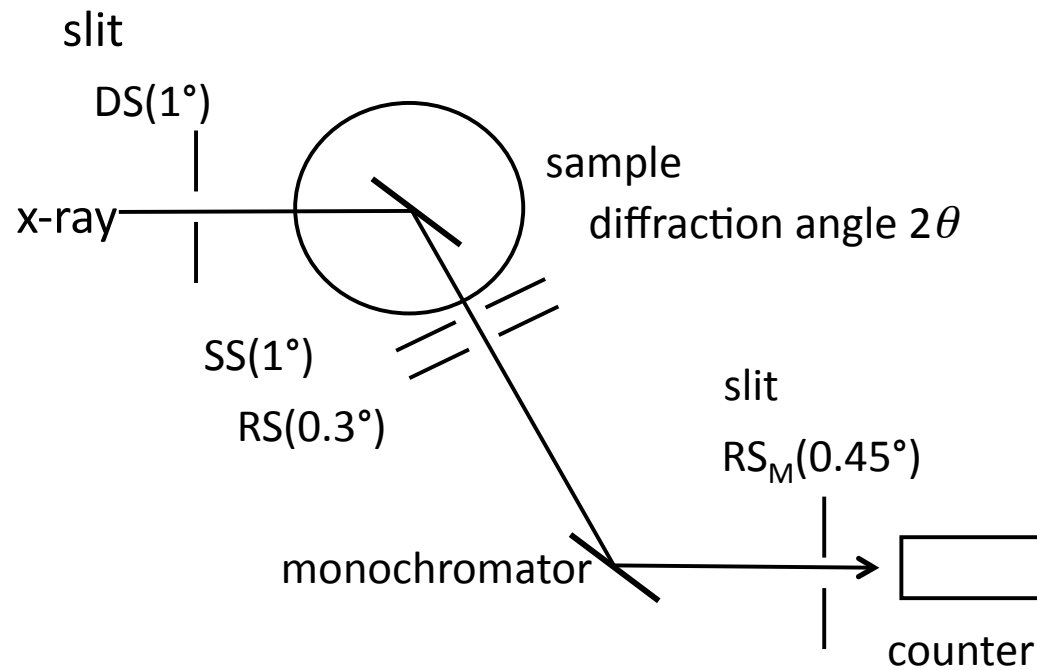
He discovered “x-ray” by earnestly “endlessly” increasing the voltage of electrodes in his discharge tube.



**hospital**



# X-ray diffraction (XRD)



a machine for XRD measurements

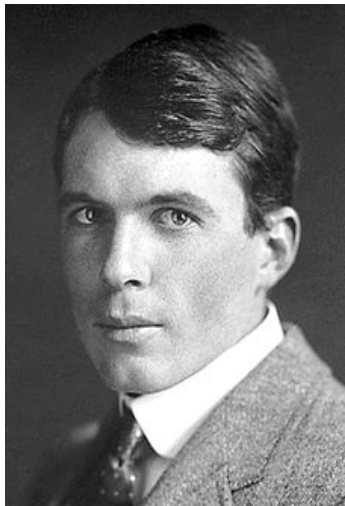


RINT-TTR III, Rigaku

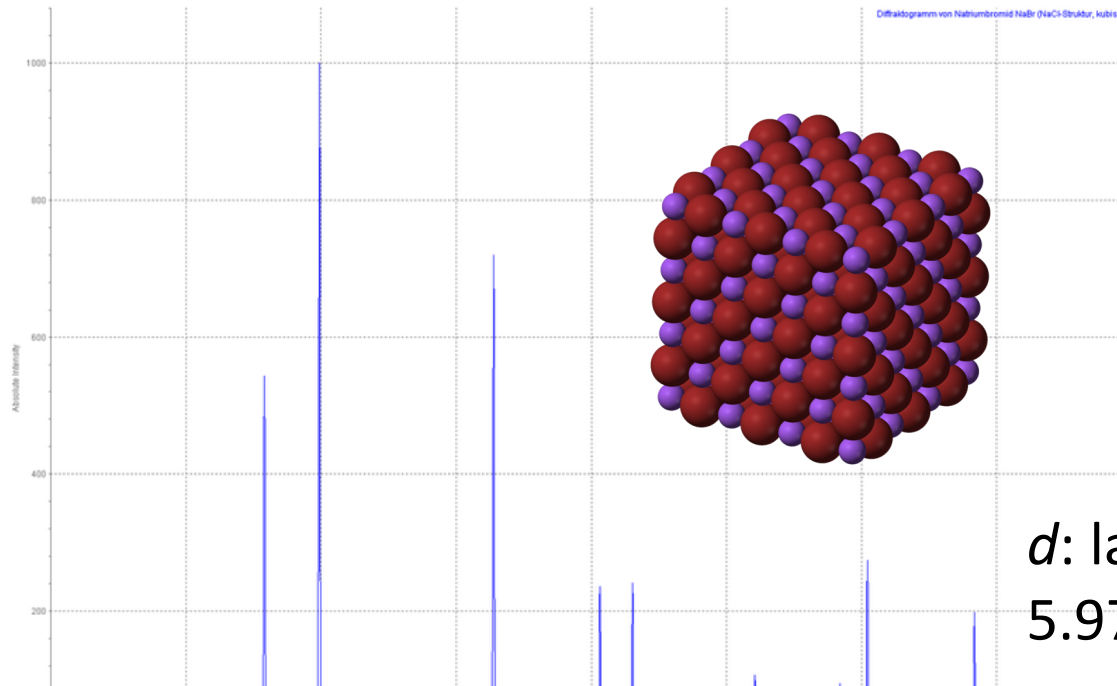
# an XRD spectrum of NaBr

*What is the ruler here?*

**The wave length of the x-ray is used as a ruler to measure the lattice constant.**



W. L. Bragg  
(1890-1971)



Bragg's law

$$2d\sin\theta = n\lambda$$

$d$ : lattice constant  
5.97 Å

***Long range order is required for XRD measurements.***

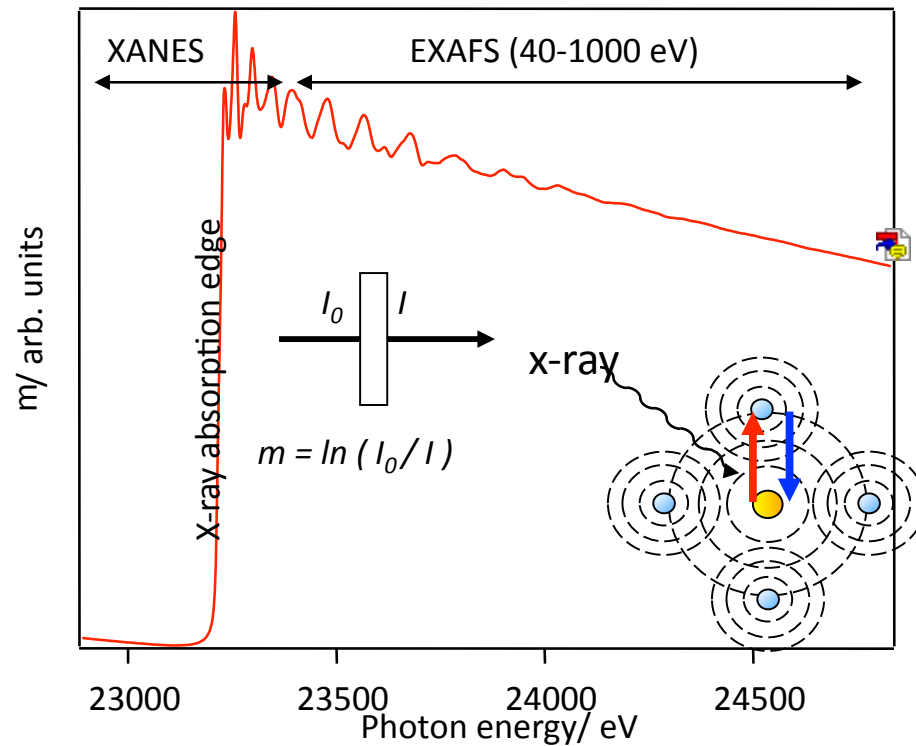
***No (practical) element specificity***

# Simple things XAFS spectra give us

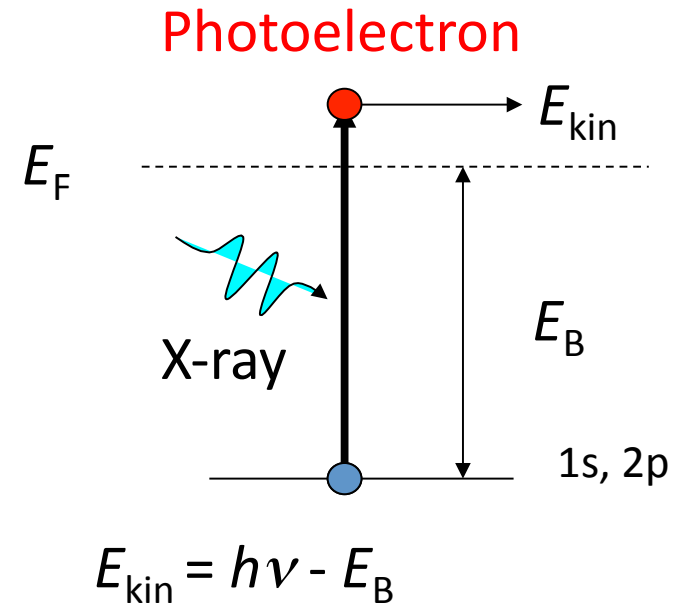
- XANES gives us...
    - Valence state
      - We can determine our sample as a certain molecule or material.
    - Symmetry
  - EXAFS gives us...
    - Bond length
      - **A local structure** is given.
      - **Crystallinity, or long range order is not required.**
    - Coordination number (CN)
      - Simply, the number of atoms around the atom.
      - CN enables us to estimate sizes of nano clusters.
- with element specificity*

# XAFS

- ✓ X-ray Absorption Fine Structure(XAFS)
  - ✓ XANES(X-ray Absorption Near Edge Structure)
  - ✓ EXAFS(Extended X-ray Absorption Fine Structure)



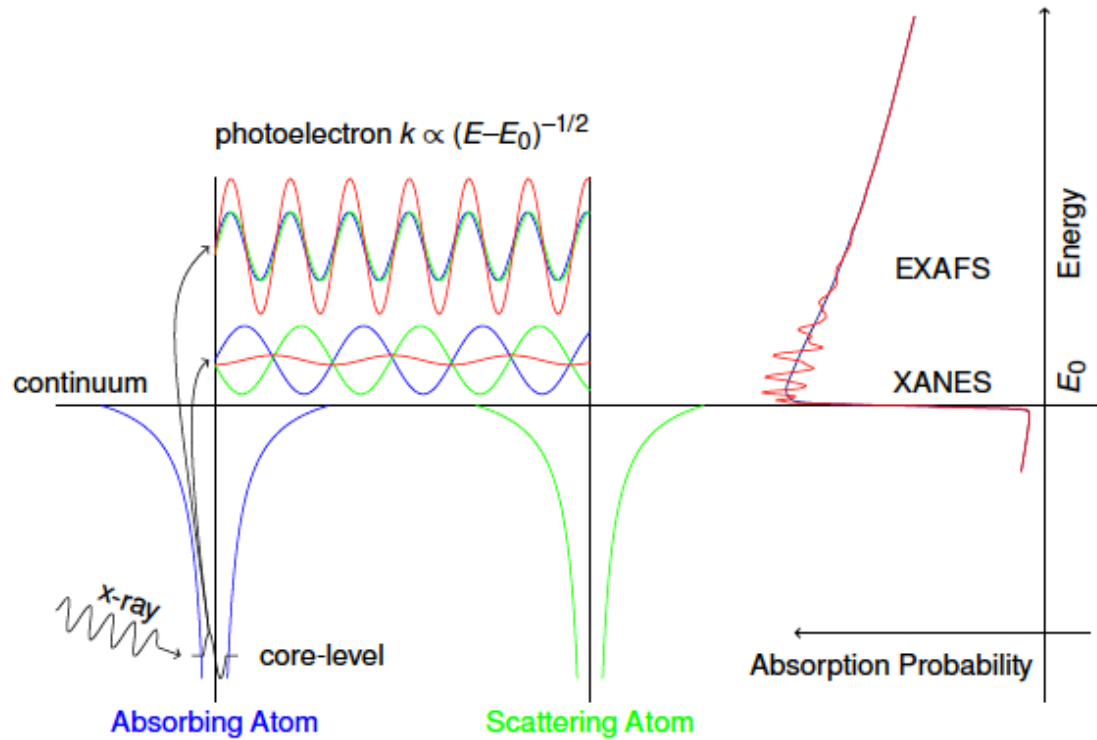
X-ray absorption spectrum



1s electron *K* shell  
2p electron *L* shell

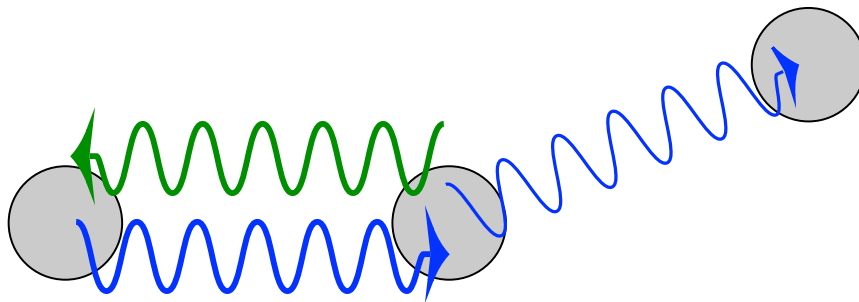


# Picture of the wave function of final state in EXAFS



“Photoelectron (wave)” emitted  
↓  
scattered by the surrounding atoms

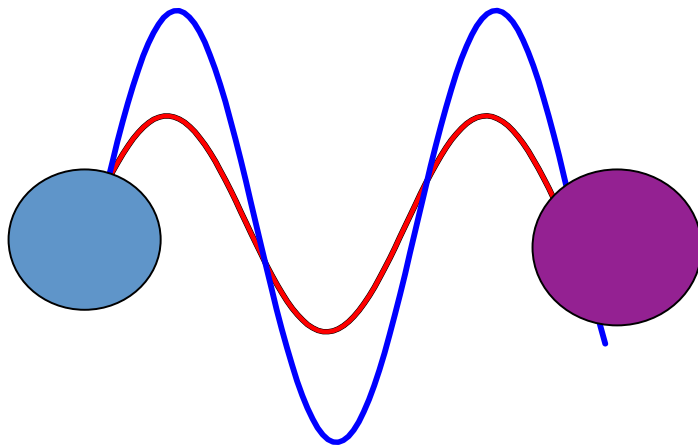
↓  
Wave function of the final state  
pictured by “quantum theory of  
scattering”



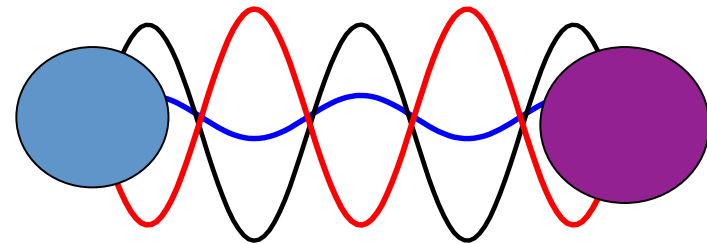
# Scattering of electron and interference

$$\frac{\hbar^2 k^2}{2m} = E - E_0$$

$K$  : wave vector  
 $\hbar$  : Plank Const.  
 $E$  : Photon energy  
 $E_0$  : threshold (edge)

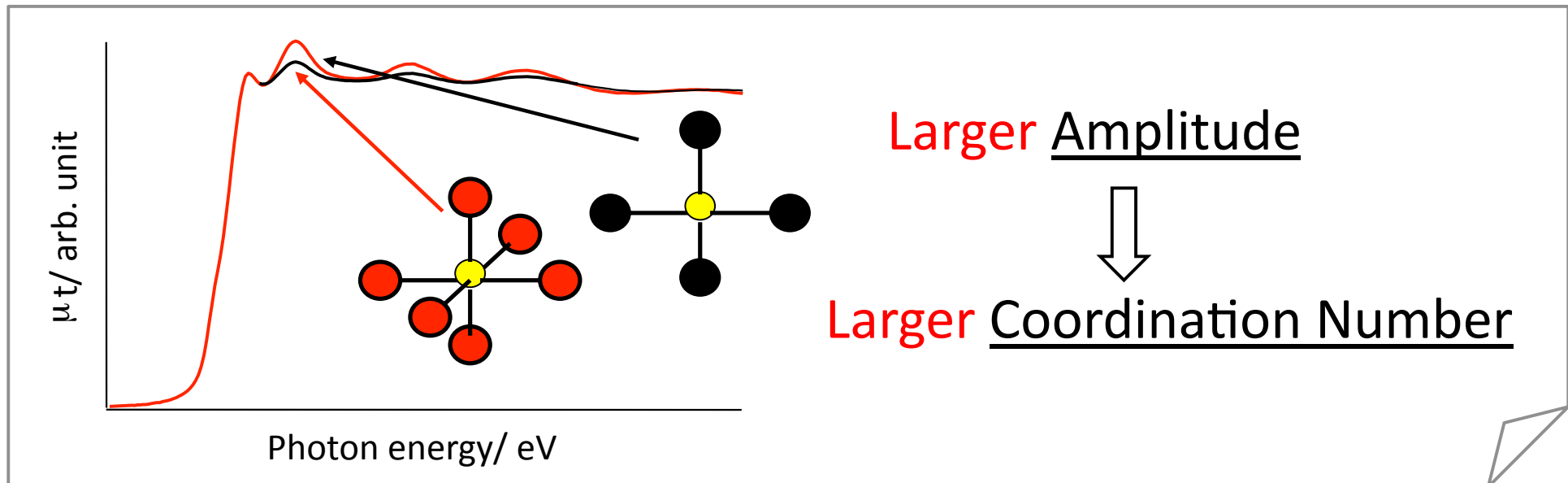
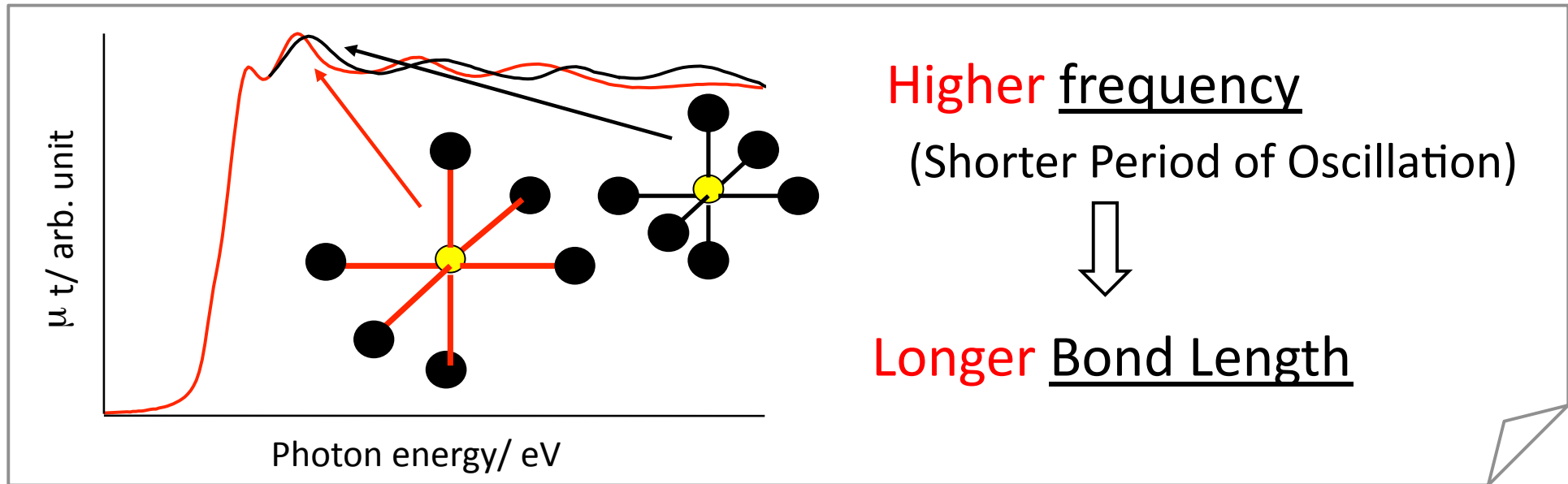


Enhancement

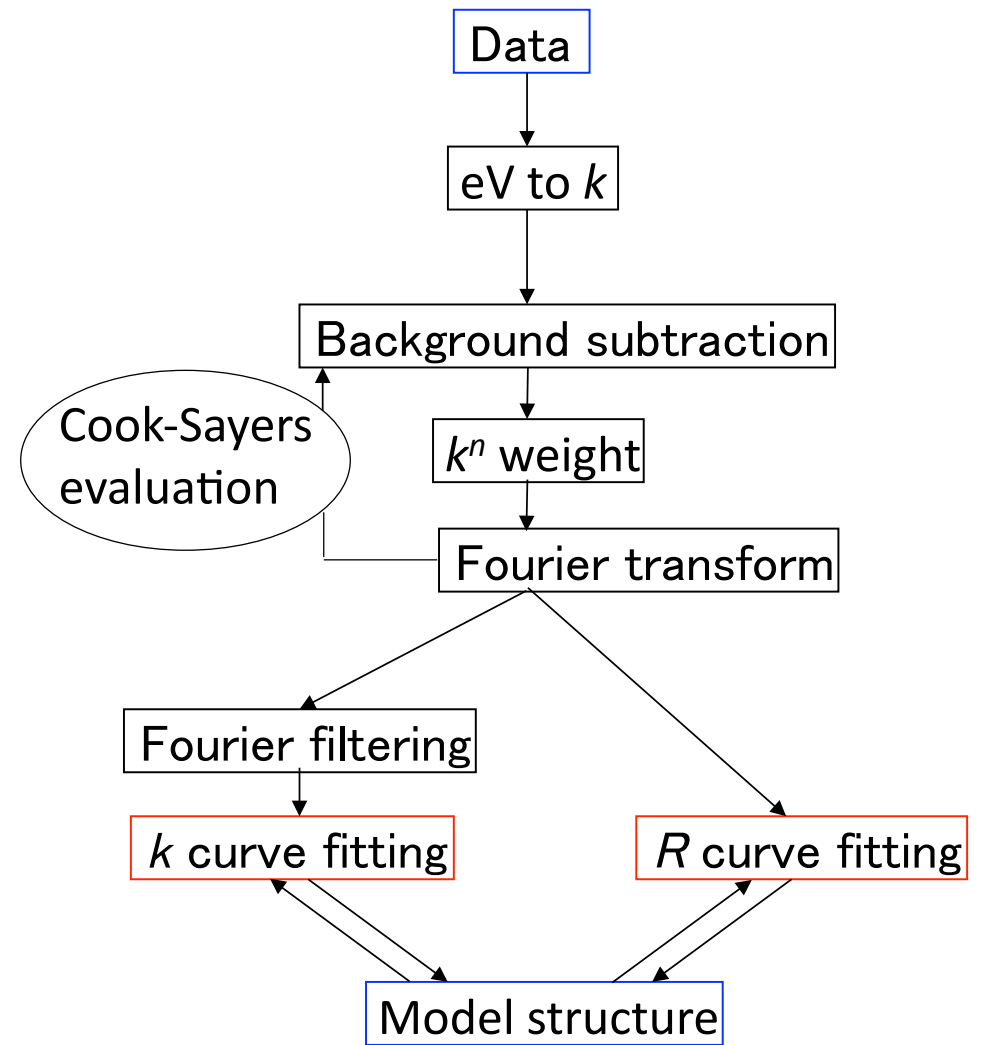
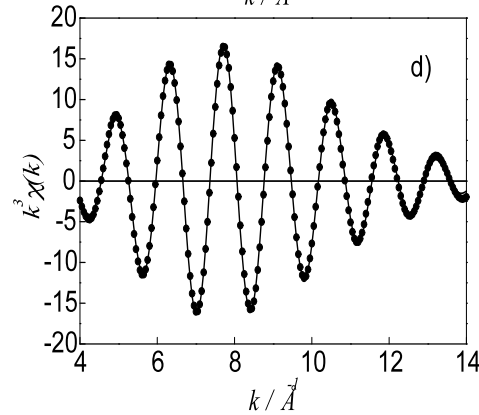
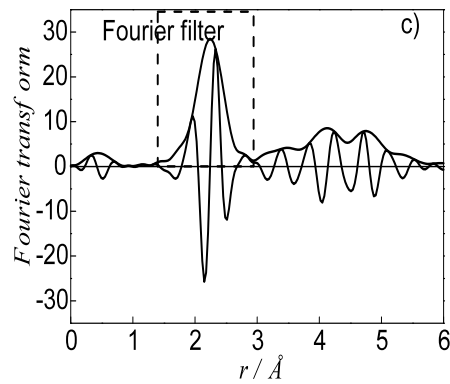
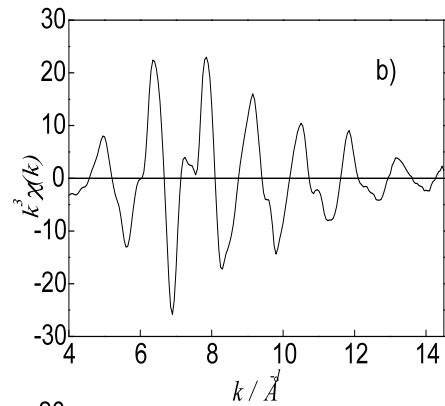
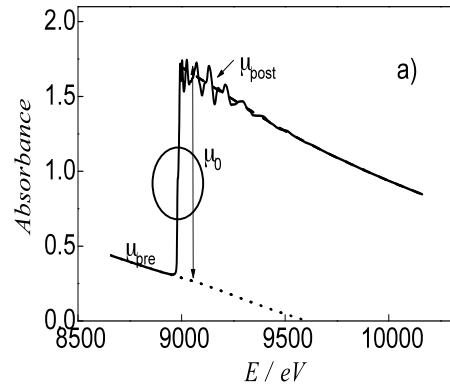


suppression

# Bond length and Coordination number

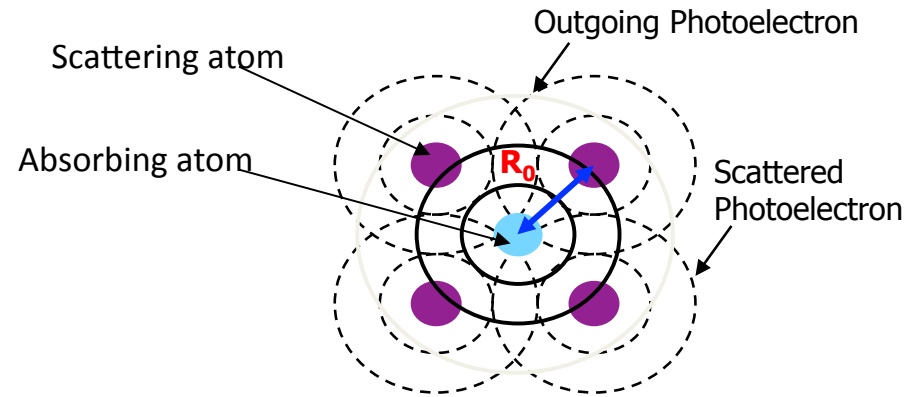


# Sketch of XAFS analysis



# The EXAFS equation

1. leaving the absorbing atom
2. scattering from the neighbor atom
3. returning to the absorbing atom



XAFS oscillation      Absorbance      Smooth background

$$\chi(k) = \frac{\mu(E) - \mu_s(E)}{\mu_0(E)} = S_0^2 \sum_i \frac{N_i F_i(k_i)}{k_i r_i^2} e^{-2k_i^2 \sigma_i^2} \sin(2k_i r_i + \phi_i(k_i))$$

Edge-jump

$$k = \sqrt{2m_e(E - E_0) / \hbar}$$

Theoretically or empirically derived  
Parameters

$F_i$  : Backscattering amplitude

\*  $e^{-2r_i / \lambda(k_i)}$

$\phi_i$  : Phase shift

Curve-Fitting Parameters

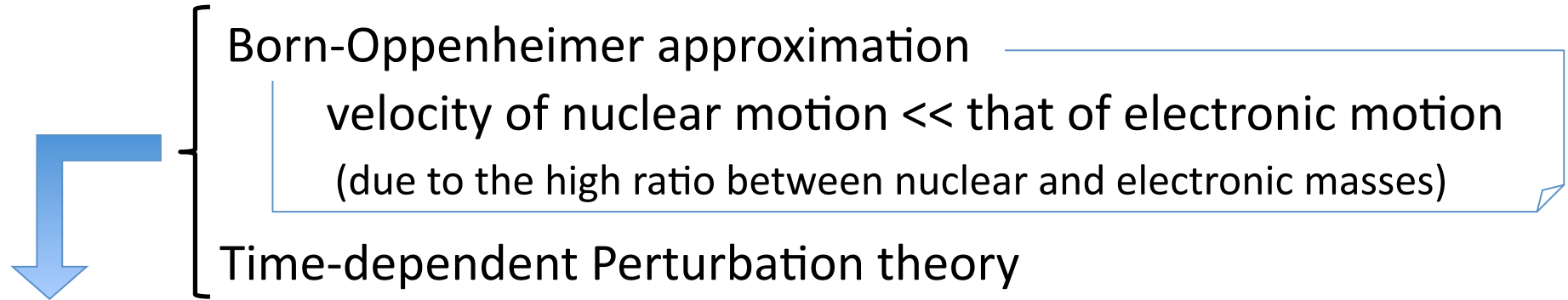
$N_i$  Coordination number

$\sigma_i^2$  DWfactor

$E_0$  energy shift

$r$  distance

# Fermi's Golden Rule to express $\mu$ of XAFS



## Fermi's Golden Rule

$$\mu \propto \sum_f \left| \langle \Psi_f | H' | \Psi_i \rangle \right|^2 \delta(E_f - E_i - \hbar\omega) \quad \dots(1)$$

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$$H' = -\frac{e}{mc} A(r) \cdot P$$

vector potential of X-ray

momentum of electron

$$A(r) = \hat{e} A_0 e^{ik \cdot r}$$

unit vector of electric field

position of electron


wave number vector of X-ray

# One-electron approx. & Dipole approx.

$$\mu \propto \sum_f \left| \langle \Psi_f | H' | \Psi_i \rangle \right|^2 \delta(E_f - E_i - \hbar\omega) \quad \dots(1)$$

*EXAFS is “just” an absorption spectroscopy!!  
(described by a simple dipole term)*

*Don't be afraid to get in it!!*


$$\mu \propto \sum_f \left| \langle \psi_f | \hat{e} \cdot r | \psi_i \rangle \right|^2 \delta(E_f - E_i - \hbar\omega) \quad \dots(2)$$

fundamental equation to express XAFS

# Eq. of single scattering EXAFS

$$\chi(k) = -S_0^2 \sum_j \frac{N_j}{kR_j^2} F_j(k) \exp(-2\sigma_j^2 k^2) \sin(2kR_j + 2\delta_{A,1}(k) + \varphi_j(k))$$

Amplitude Oscillation (phase)

"Round trip" of the wave

Phase shift

of absorbing atom

of scattering atom

*Fourier Transform...*

Bond length  $R_j$ , etc.,

(Parameters high-lightened by yellow are fitting parameters.)



# de Broglie wave as a Ruler

A particle with the momentum of  $p$   
having the wave character described by the below Eq.

as for Electron

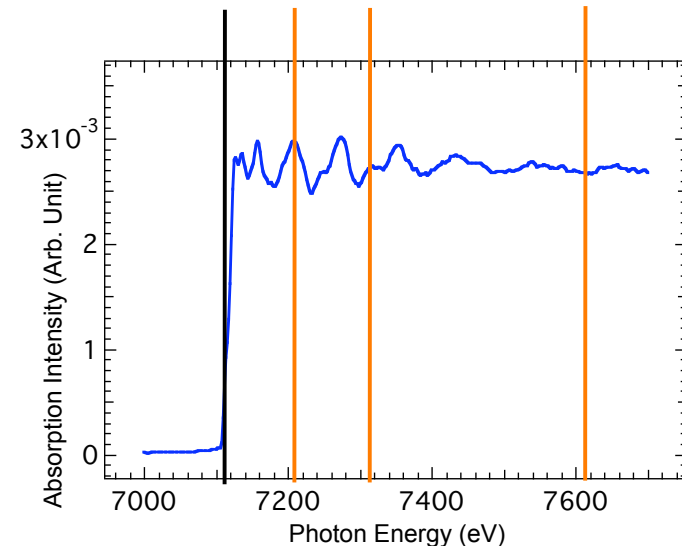
$$\lambda = \frac{h}{p} = \frac{h}{(2m_e eV)^{1/2}}$$

*considering a bond length of  $\sim 2.5 \text{ \AA}$*

100 eV: 1.226 $\text{\AA}$	2 waves
200 eV: 0.867 $\text{\AA}$	3 waves
500 eV: 0.548 $\text{\AA}$	4-5 waves

EXAFS

We use **de Broglie wave of electron** as a **Ruler**, in order to measure bond length

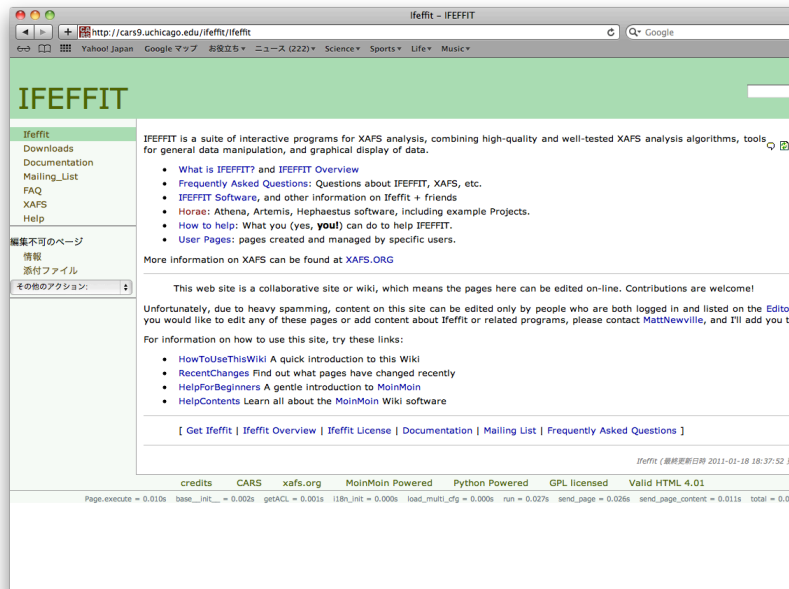


# Software for XAFS analyses

Athena, Artemis (Ifeffit)

by a group at U. Chicago

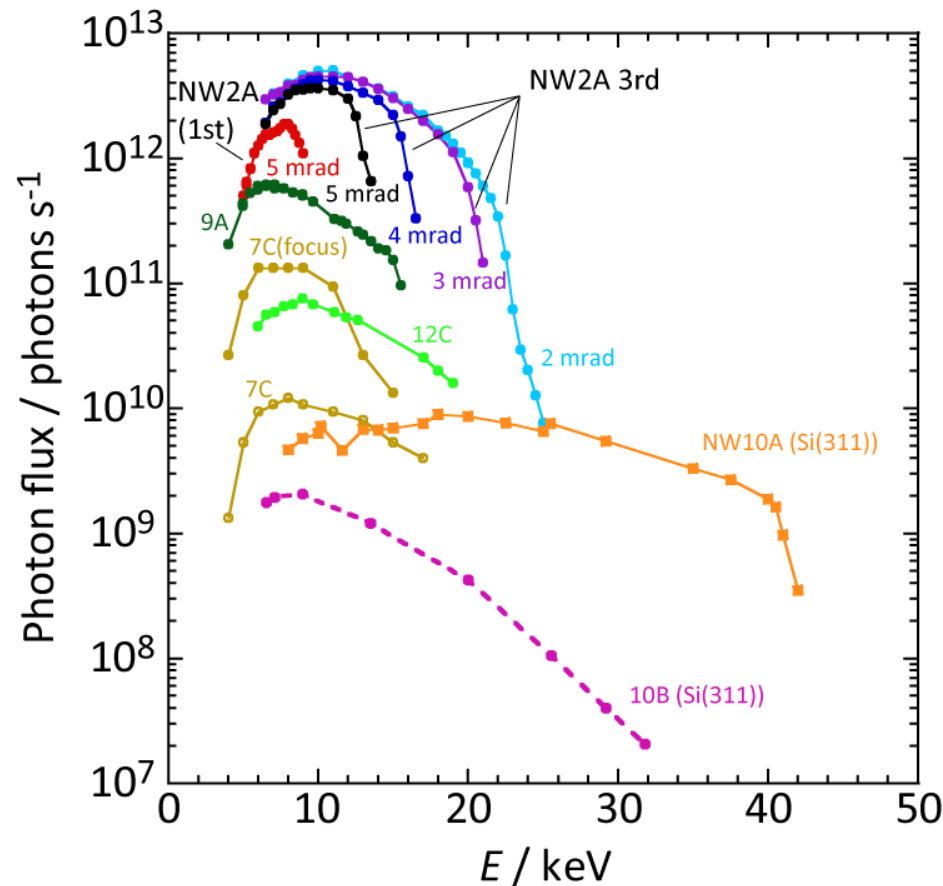
<http://cars9.uchicago.edu/ifeffit/Ifef>



*Of course, there are many other softwares, and you can use what you'd like to.*

# Experiments of XAFS

# Stations of XAFS experiments at PF



PF BL-9A

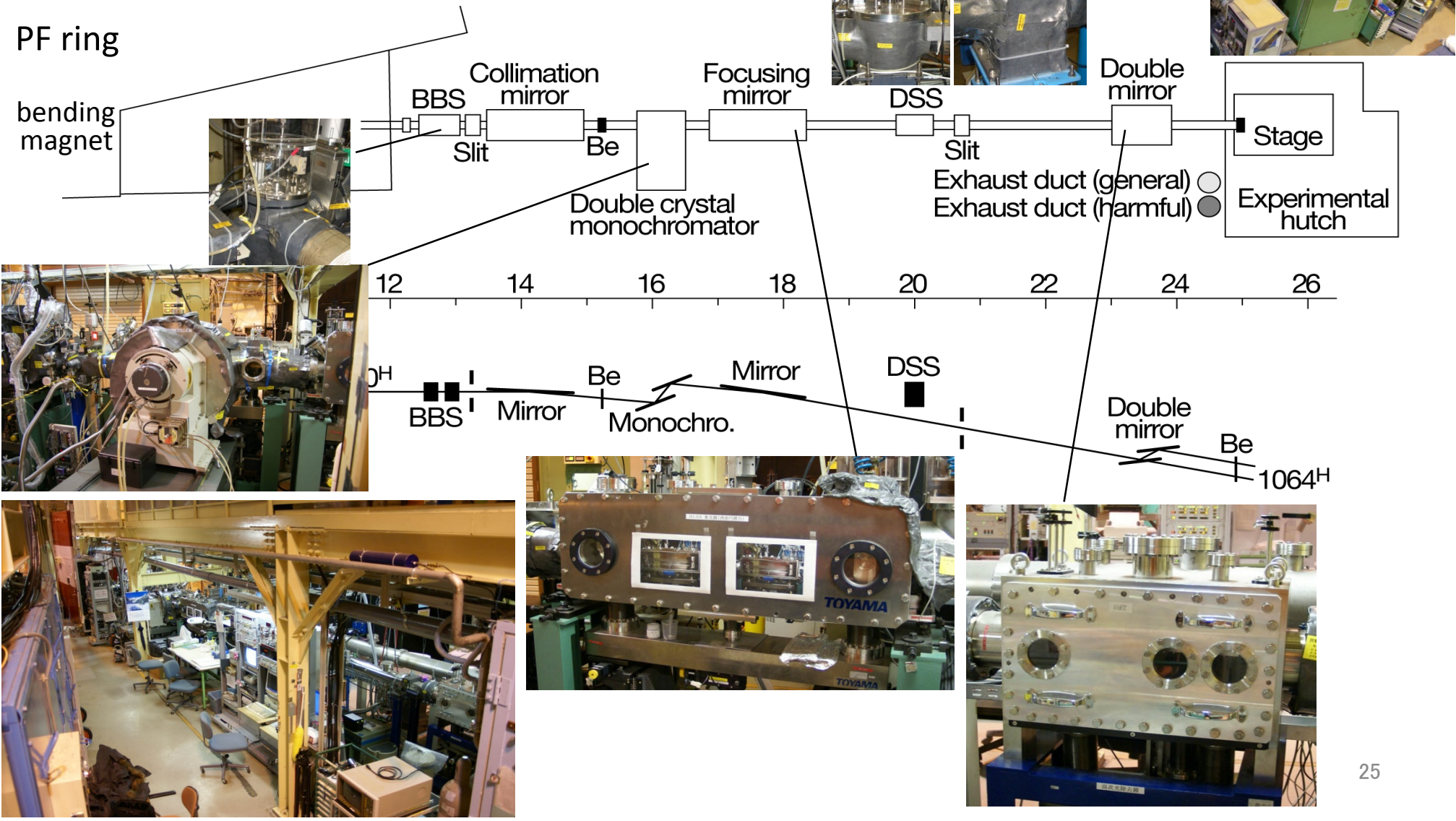


*K* edges: from P (~2.1 keV) to Ce (~40 keV)

*L* edges: from Mo (~2.5 keV) to U (~21 keV)



# Schematic of BL-9A



# Ionization chamber for x-ray detection



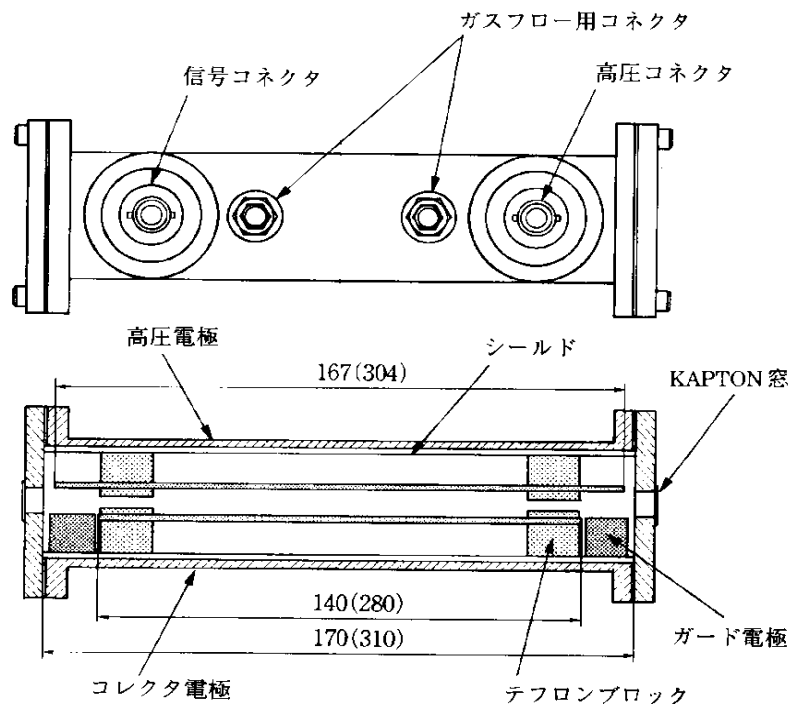
We measure the current produced by ionization of gas by incoming x-ray.

Current  $i$ ; measuring with  $N_2$  flowing ion chamber to detect x-ray of 8 keV;

$$i \approx 8.5 \times 10^{-8} \text{ A}$$

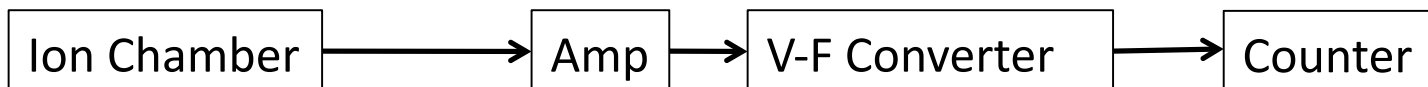
$$i = \frac{\alpha E e N}{W}$$

- $\alpha$  : 検出効率 (0.2)
- $E$  : 光子エネルギー (8000 eV)
- $e$  : 電荷素量 ( $1.6 \times 10^{-19}$  C)
- $N$  : 入射光子数 ( $10^{10}$  photons/s)
- $W$  : 窒素ガスのイオン化エネルギー (30 eV)



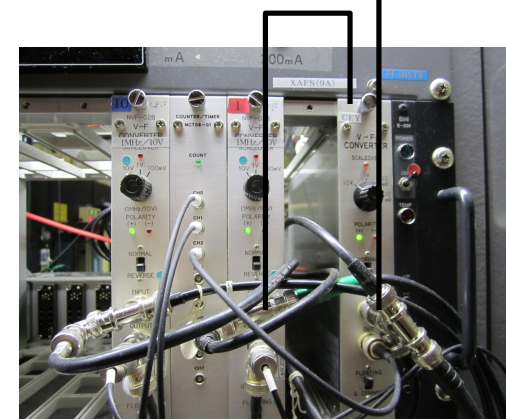
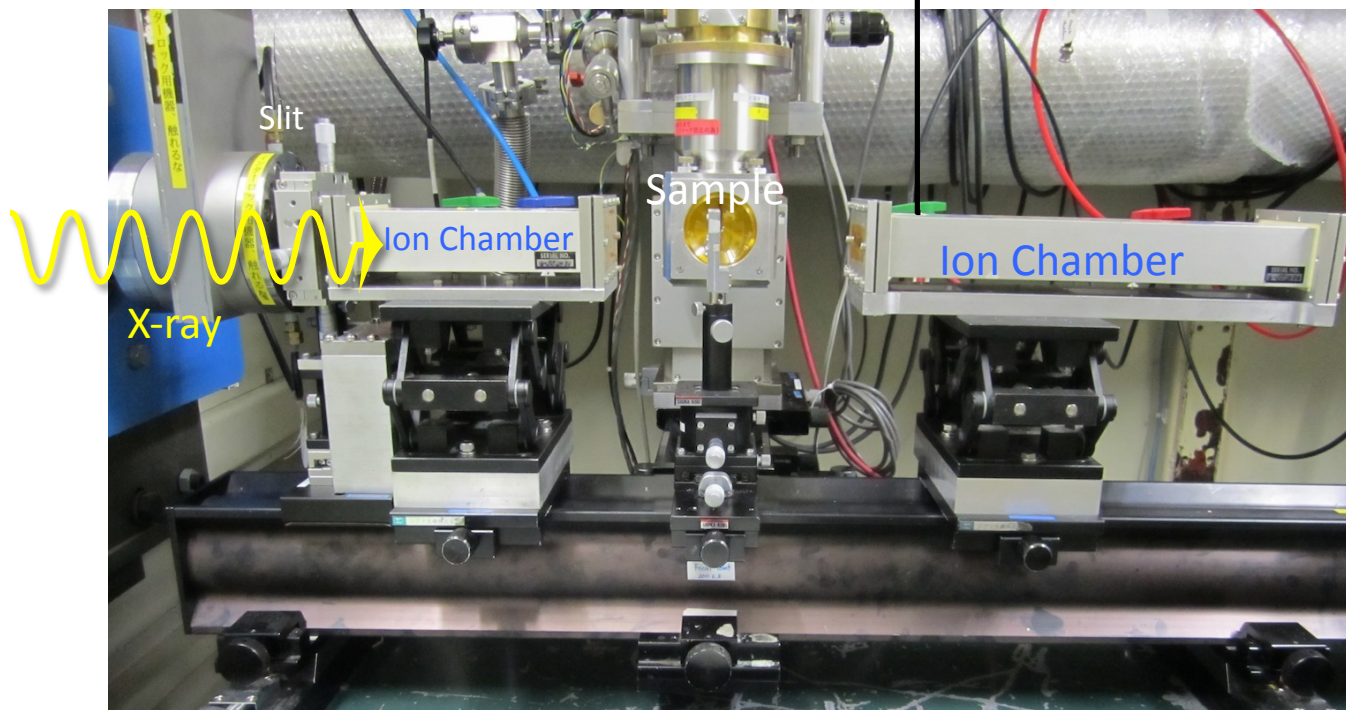


# Setup of transmission mode XAFS

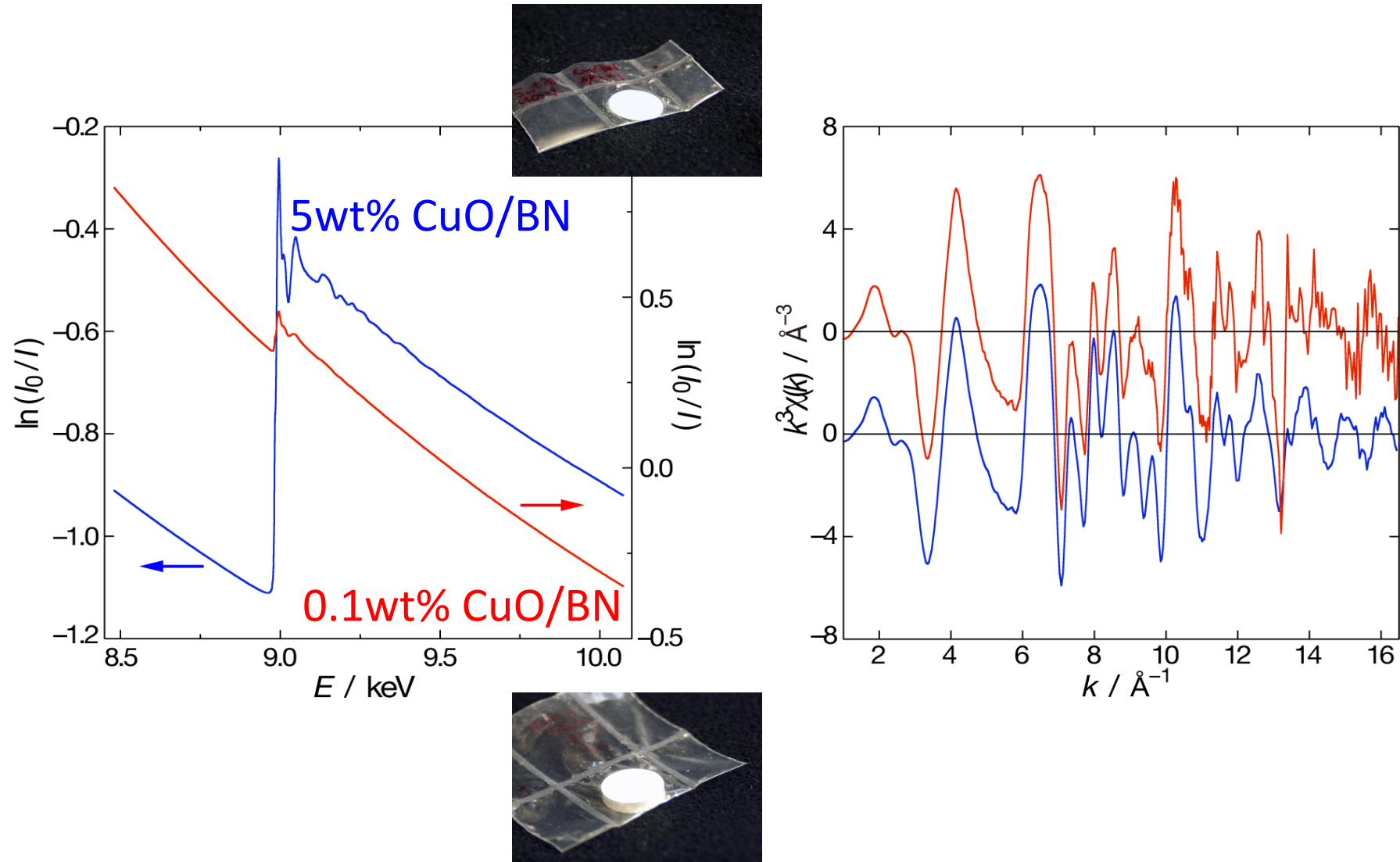


Current prop. to x-ray intensity    Cur. => Volt.    Volt. => Frequency

Absorption     $\mu t(\lambda) = \ln\left(\frac{I_0(\lambda)}{I(\lambda)}\right)$

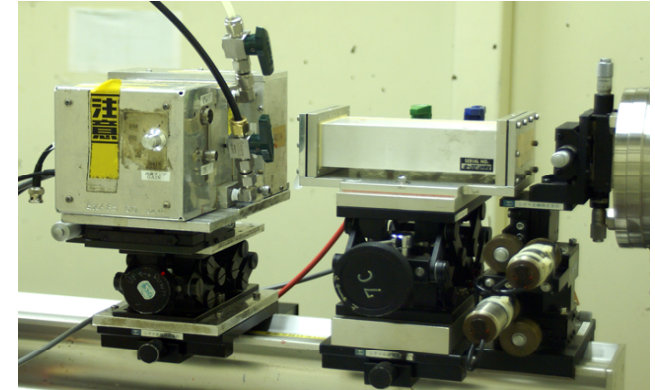
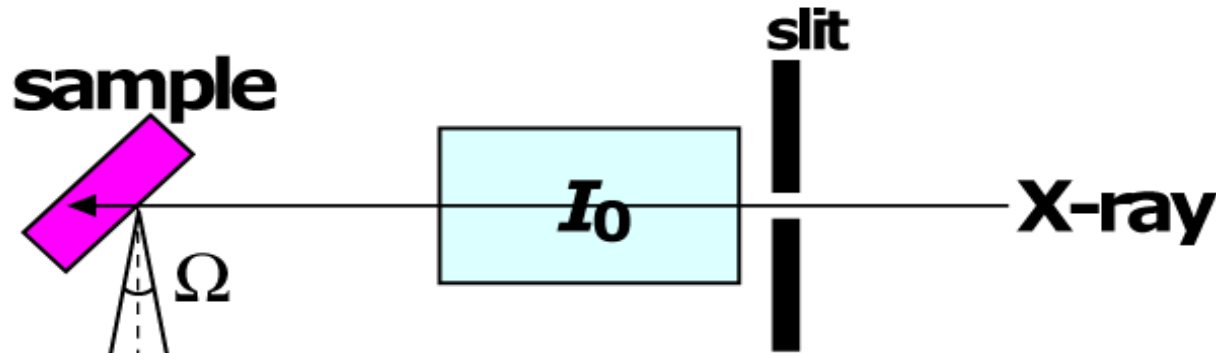


# Transmission mode XAFS spectra





# Fluorescence mode XAFS



$$I_f = I_0 \varepsilon \frac{\Omega}{4\pi} \frac{\mu_x(E)}{\mu_t(E) + \mu_t(E_f)} \left[ 1 - \exp\{-(\mu_t(E) + \mu_t(E_f))d\} \right]$$

$$\{(\mu_t(E) + \mu_t(E_f))d\} \ll 1$$

$$I_f = I_0 \varepsilon \frac{\Omega}{4\pi} \mu_x(E) d$$

$$\therefore \frac{I_f}{I_0} \propto \mu_x(E)$$

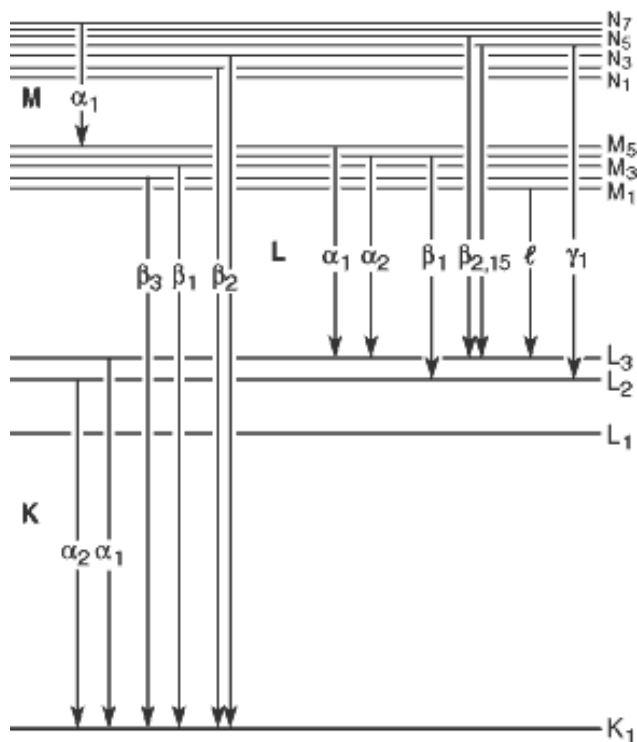
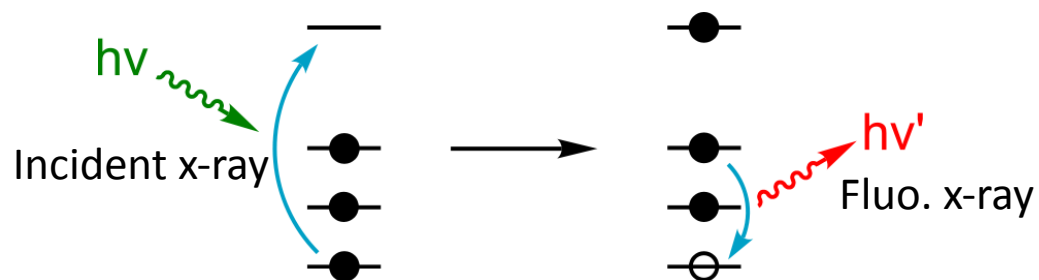
thick but dilute

(ex. 0.01 M aq.)

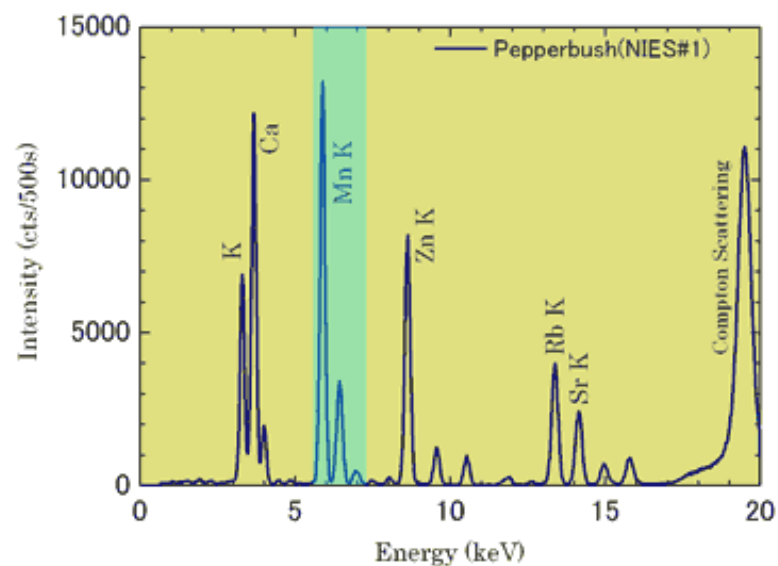
concentrated but thin

(ex. 1000 Å film)

# Element specific emission: Fluorescent x-ray



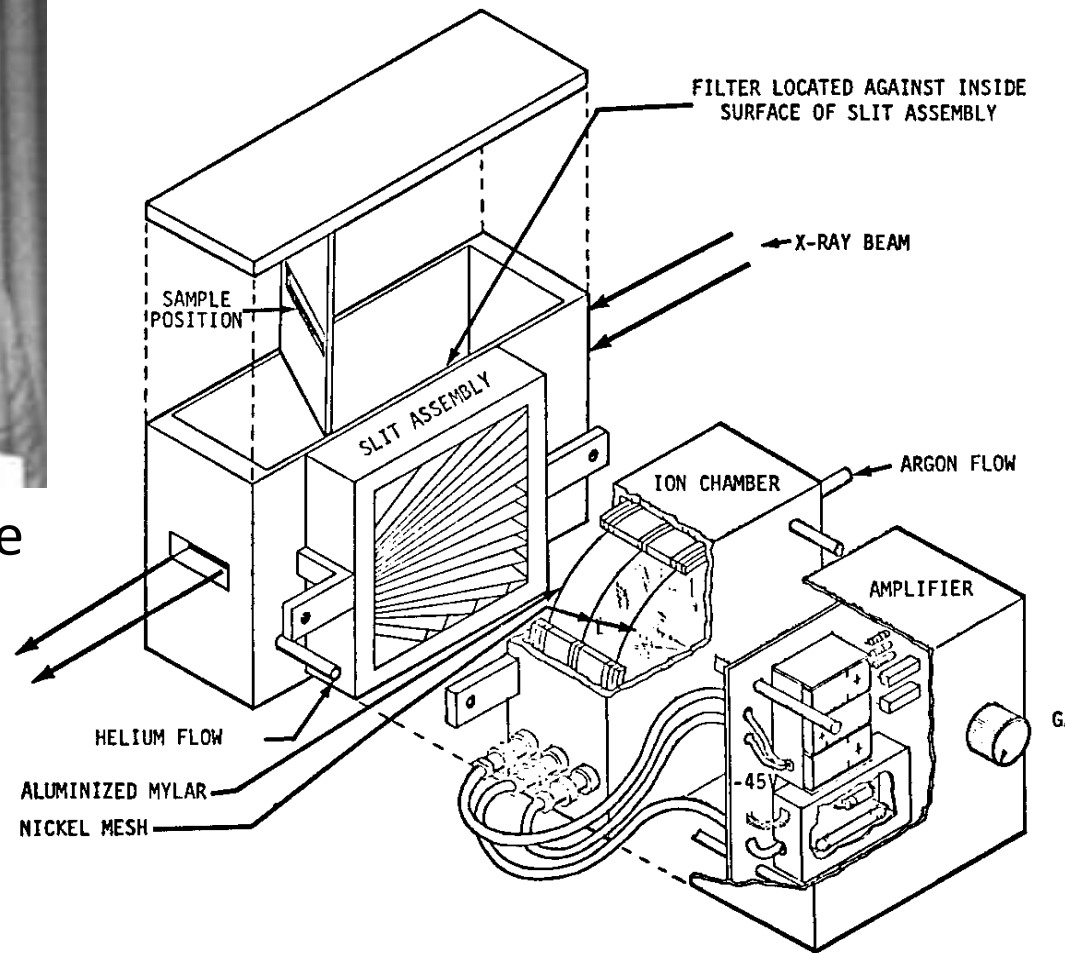
Element	$K\alpha_1$	$K\alpha_2$
22 Ti	4,510.84	4,504.86
23 V	4,952.20	4,944.64
24 Cr	5,414.72	5,405.509
25 Mn	5,898.75	5,887.65
26 Fe	6,403.84	6,390.84
27 Co	6,930.32	6,915.30
28 Ni	7,478.15	7,460.89
29 Cu	8,047.78	8,027.83
30 Zn	8,638.86	8,615.78



# Ion chamber for Fluo. XAFS: Lytle Detector

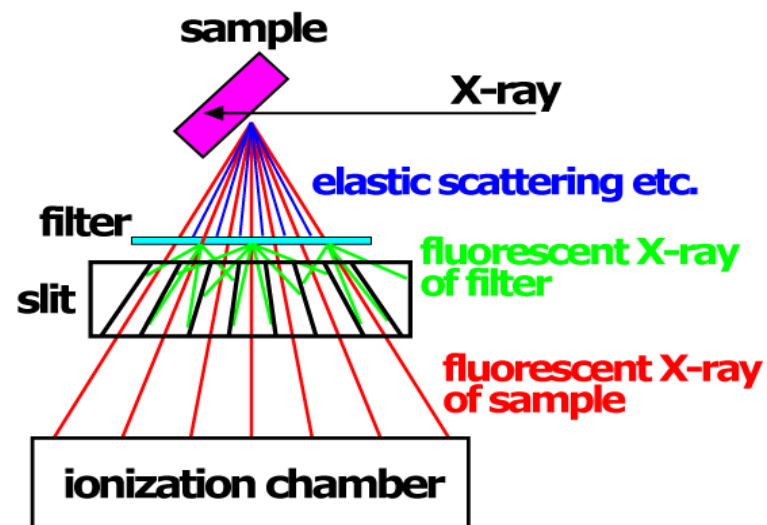


Dr. Farrel W. Lytle

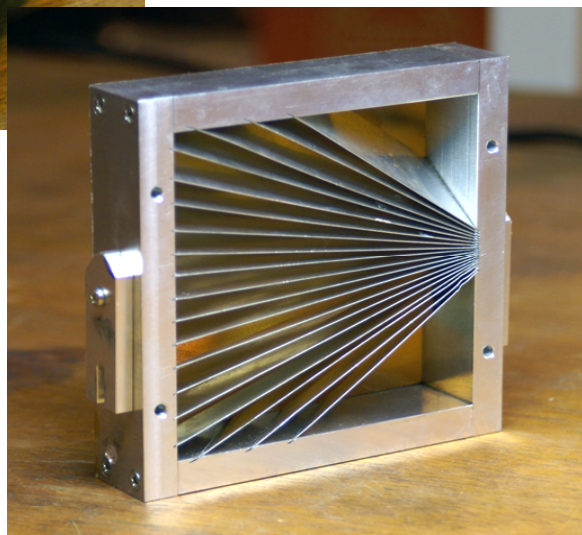


*Not expensive, large solid angle, home made possible*

# Ion chamber for Fluo. XAFS: Lytle Detector

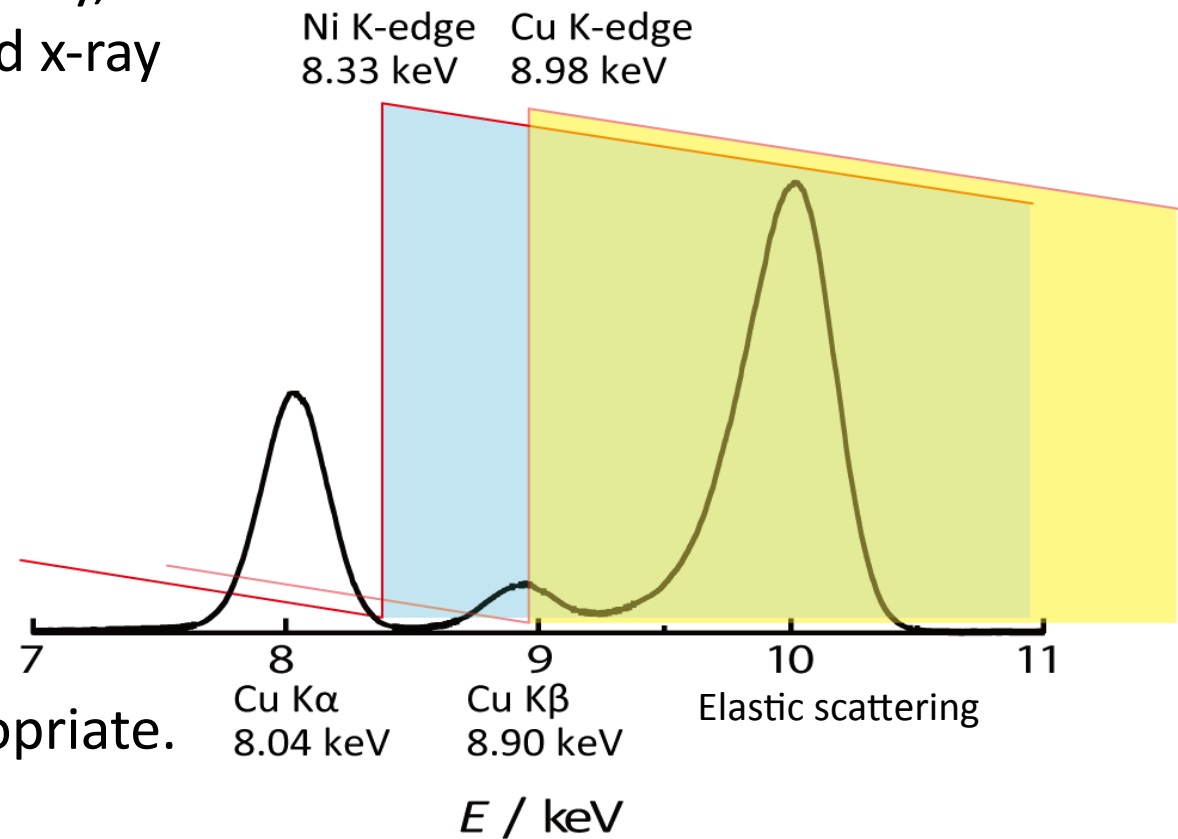


Lytle Detector made at PF



# Function of the filter

Transparent for Fluorescent x-ray,  
absorbing elastically scattered x-ray



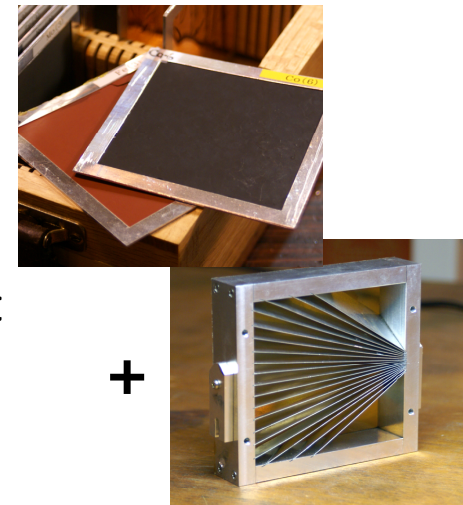
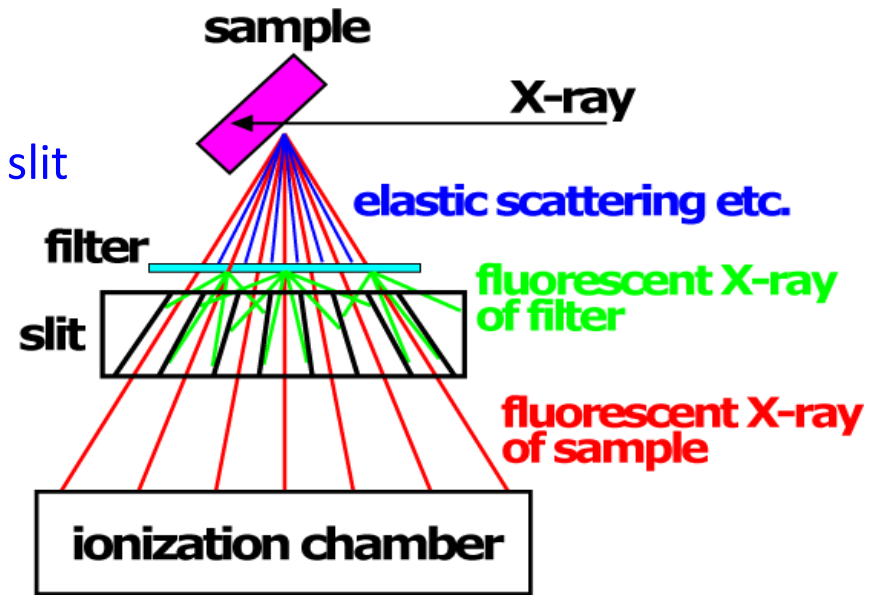
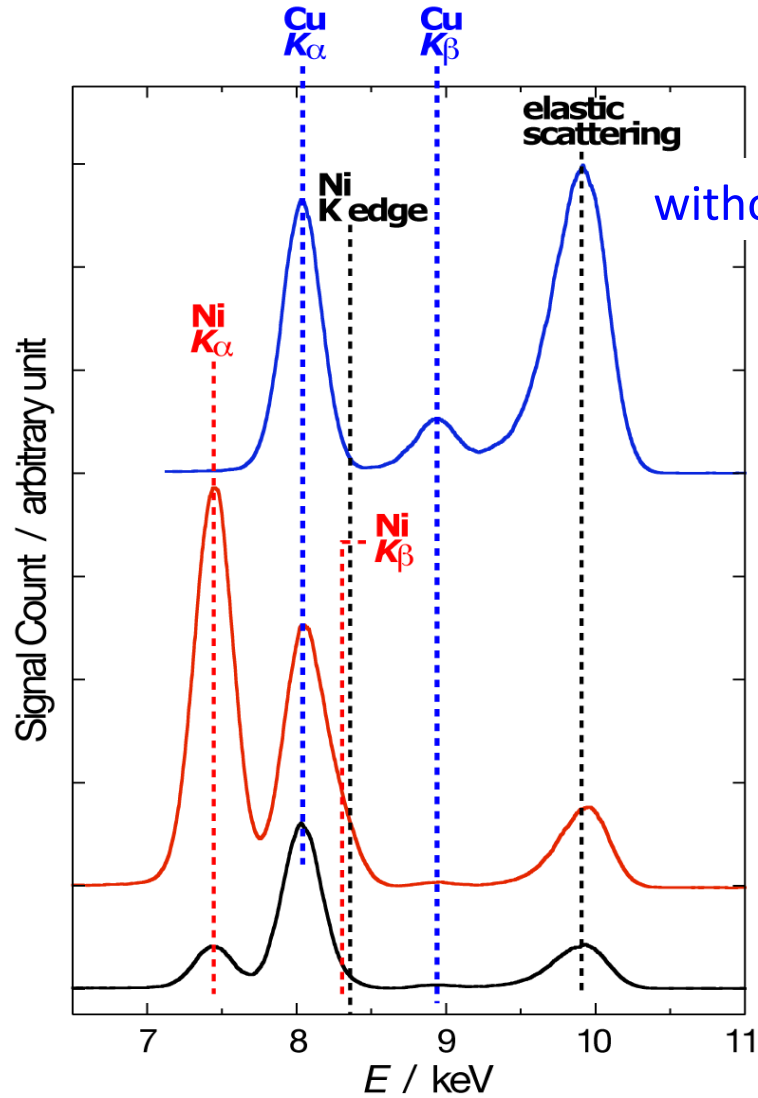
A "Z-1" filter is mostly appropriate.

*when we would like to detect Cu K $\alpha$  x-ray,*

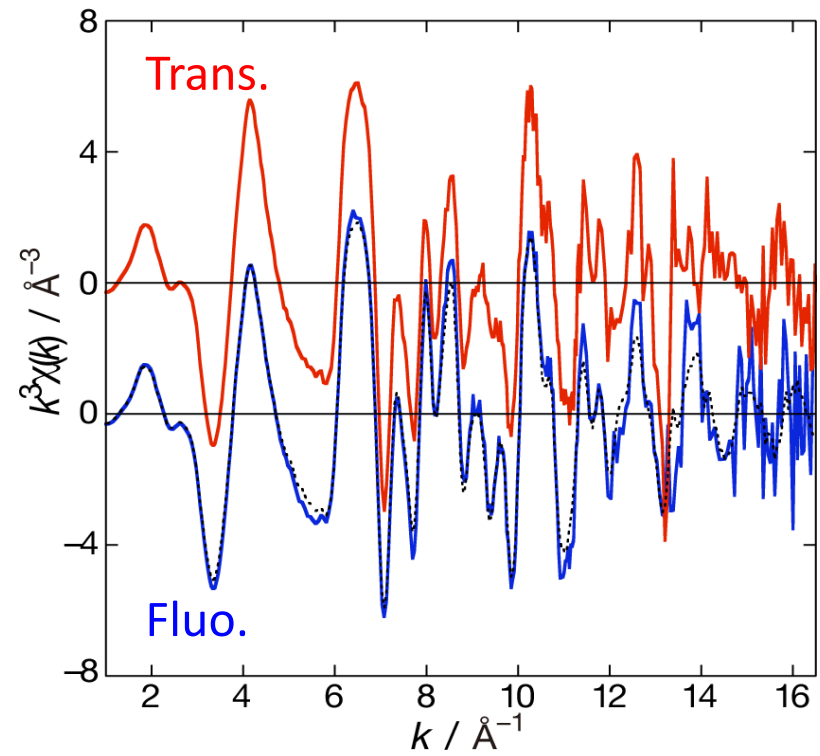
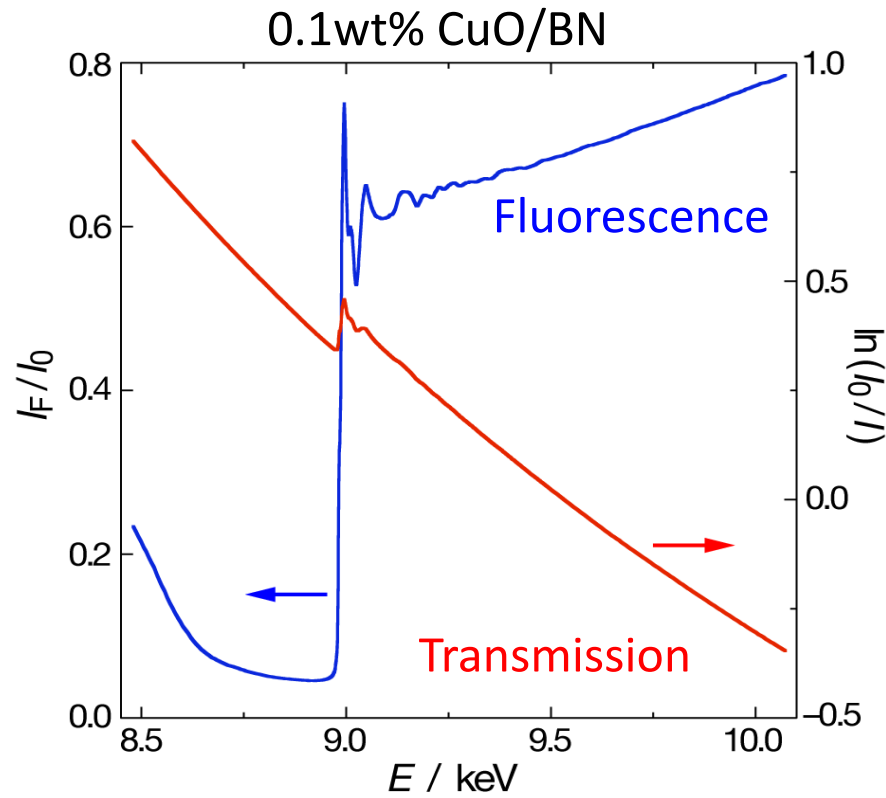
*A Ni filter is appropriate.*



# Function of Filter & Soller slit of Lytle detector

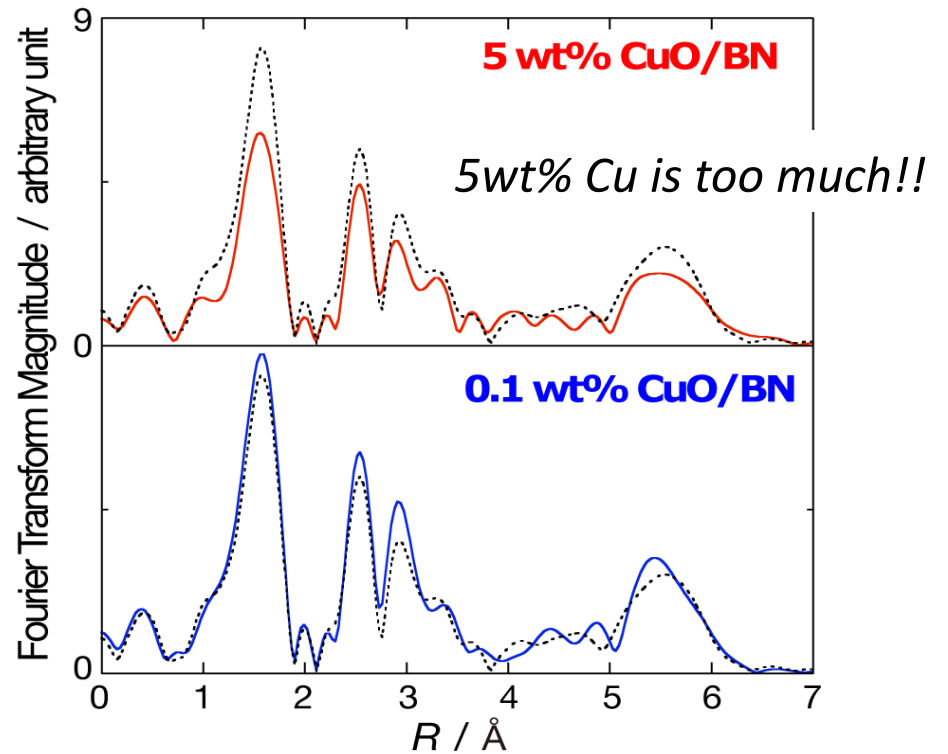
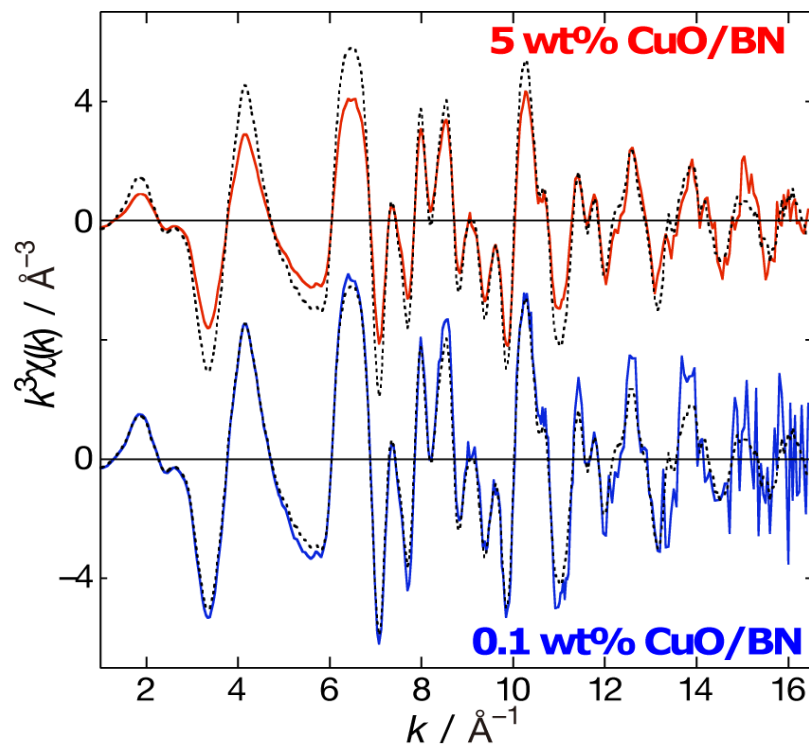


# Trans. mode & Fluo. mode



# Suitable sample for Fluo. mode XAFS

dotted line: trans mode XAFS for 5wt% sample

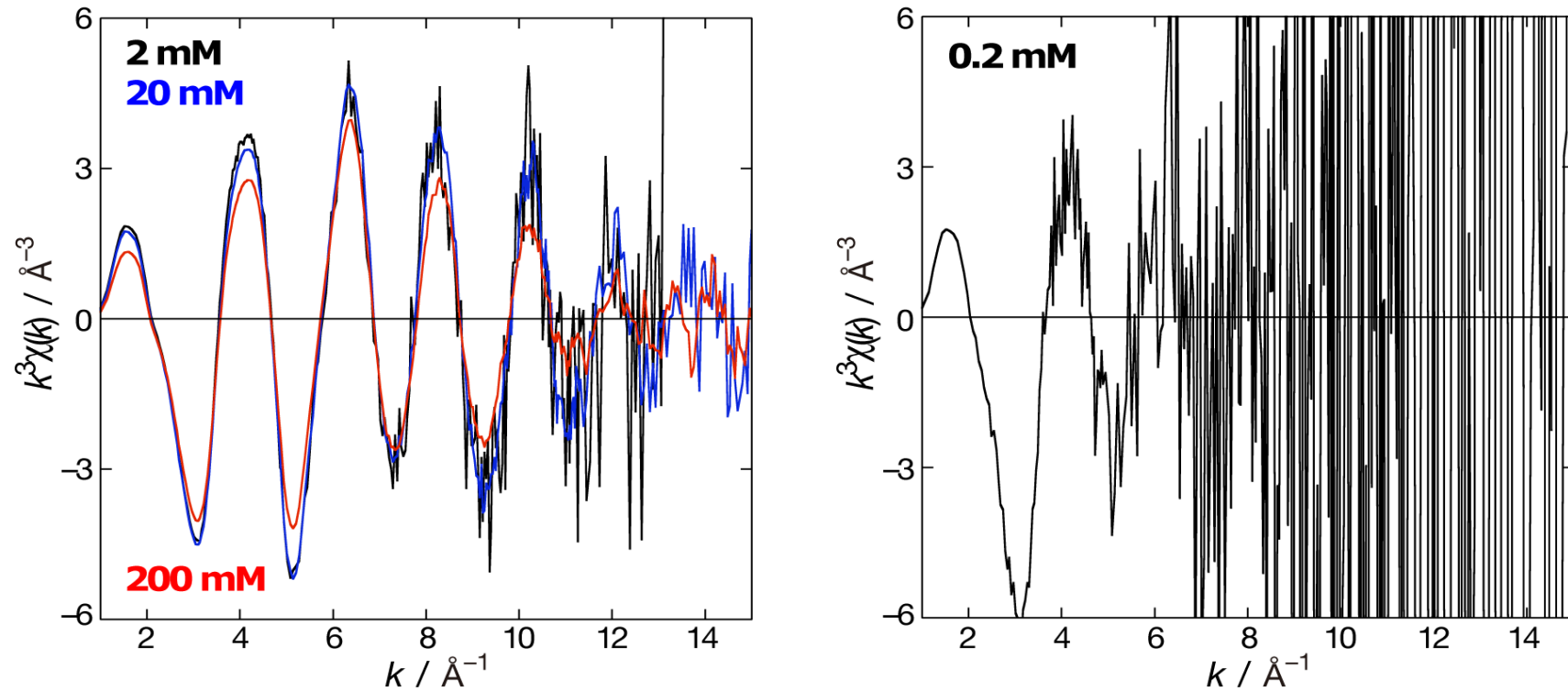


Samples for Fluo. mode XAFS must be...

- thick but **dilute**: ex. 0.01 M (10 mM) aq.
- concentrated but **thin**: ex. 1000  $\text{\AA}$  thin film



# Suitable sample condition for Fluo. mode XAFS



for CuSO<sub>4</sub> solution

density	0.2 mM	2 mM	20 mM	200 mM
weight percent	0.0013 wt%	0.013 wt%	0.13 wt%	1.3 wt%
atomic percent	0.00036 at%	0.0036 at%	0.036 at%	0.36 at%

# Si detector (Solid State Detector , SSD)

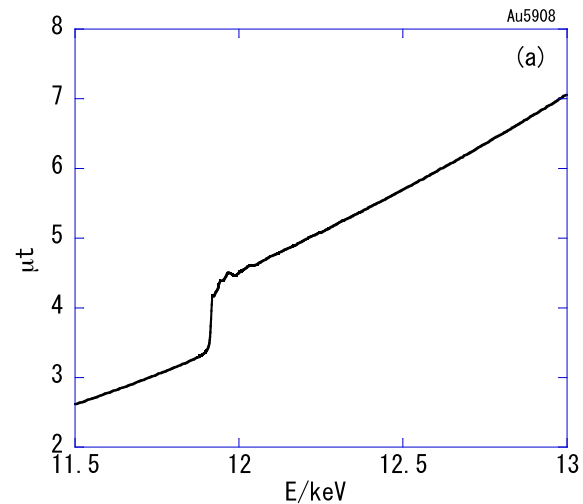
electrically energy analyzed,  
not filter or slit

$4 \times 10^{-4}$  Au in AgX

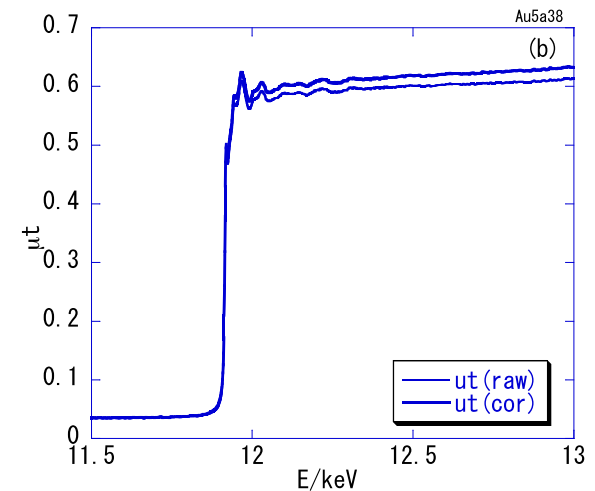


19-element SSD

Lytle detector

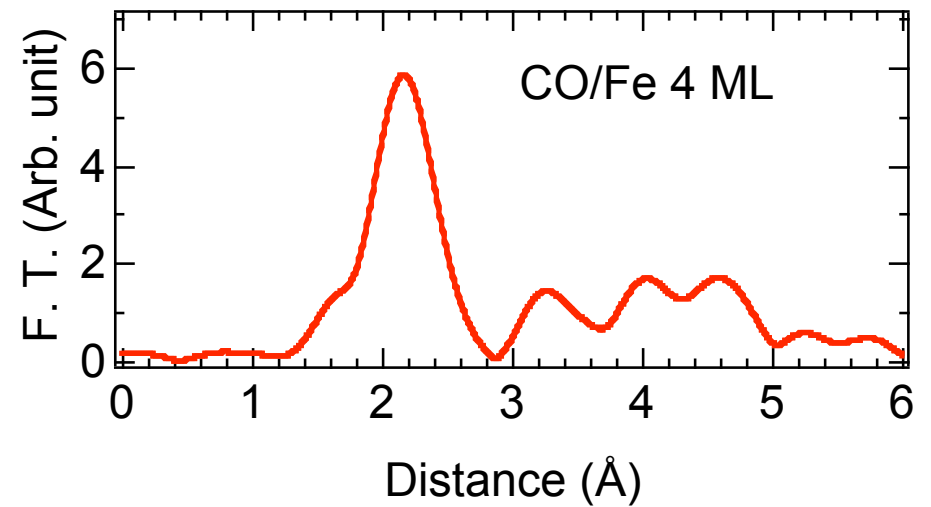
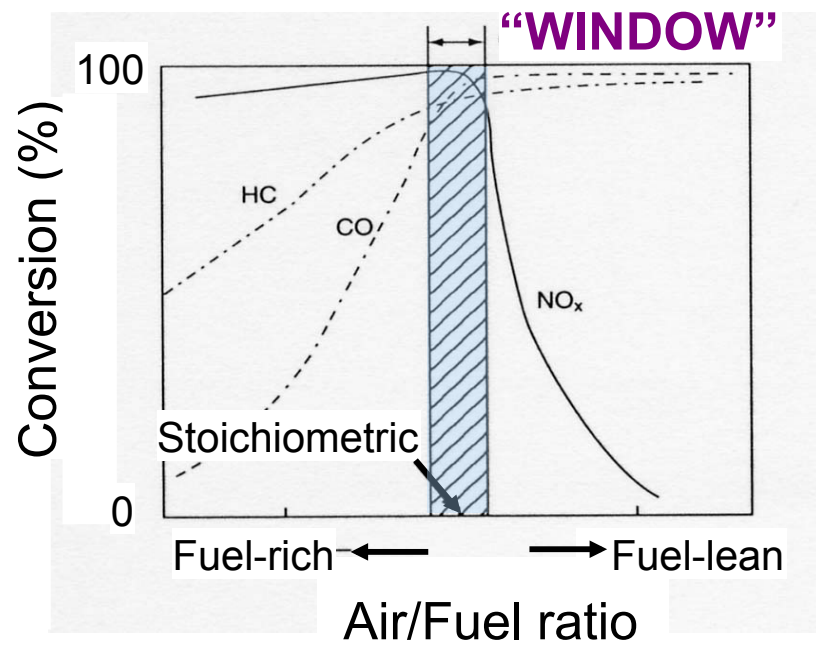
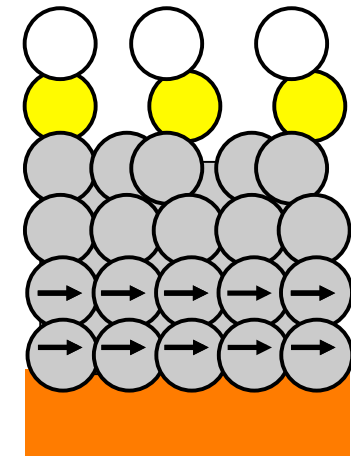
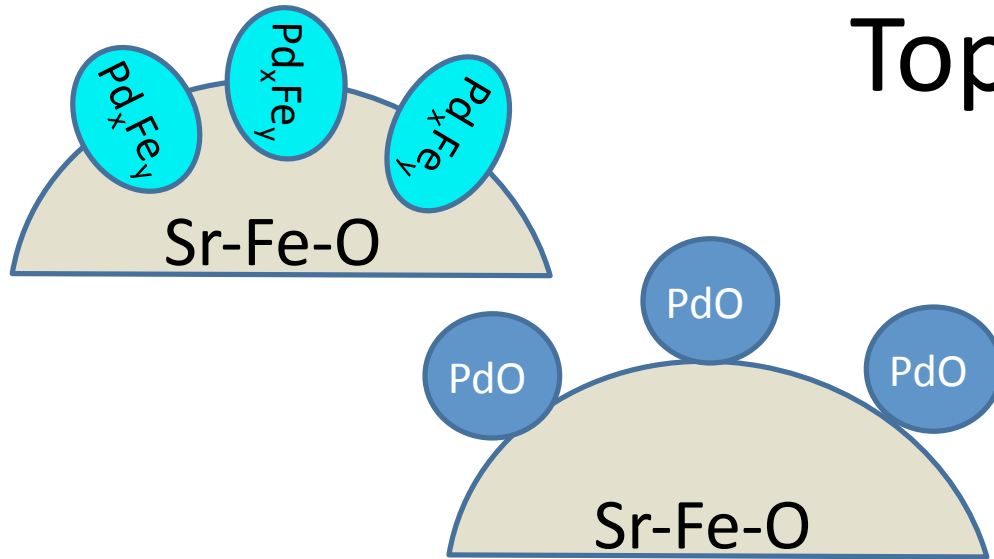


Si detector



expensive, skills required for usage and maintenance

# Topics

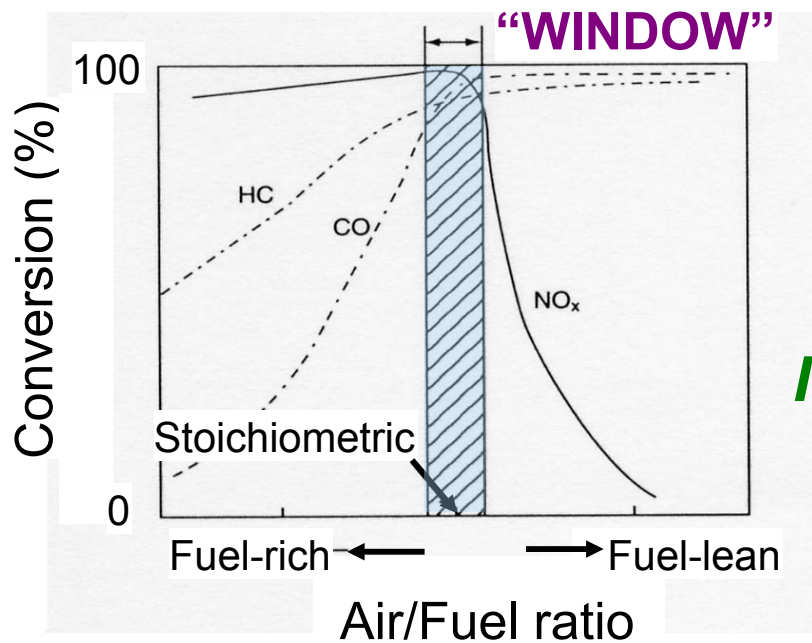
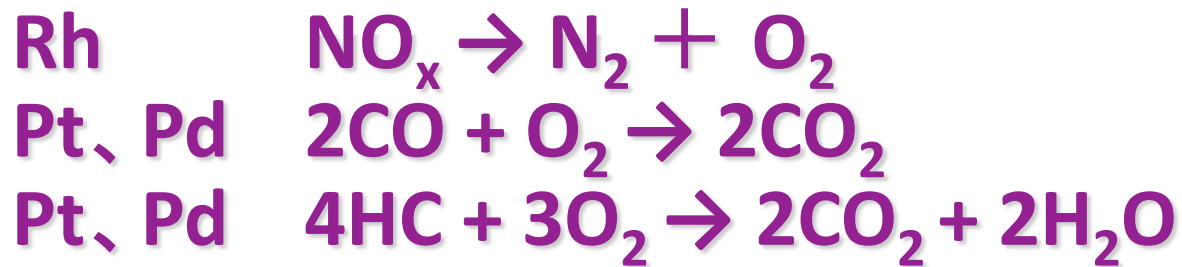


# RedOx mechanisms of Pd catalysts for automotive emission studied by XAFS

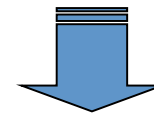
Y. Niwa<sup>1</sup>, M. Kimura<sup>2</sup>, K.Uemura<sup>2</sup>, Y. Uemura<sup>1</sup>, Y. Inada<sup>3</sup>, M. Nomura<sup>1</sup>

KEK-PF<sup>1</sup>, Nippon Steel<sup>2</sup>, Ritsumeikan Univ.<sup>3</sup>

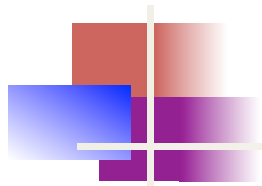
# Catalysts for automotive emission



Performance of the catalyst depends on A/F

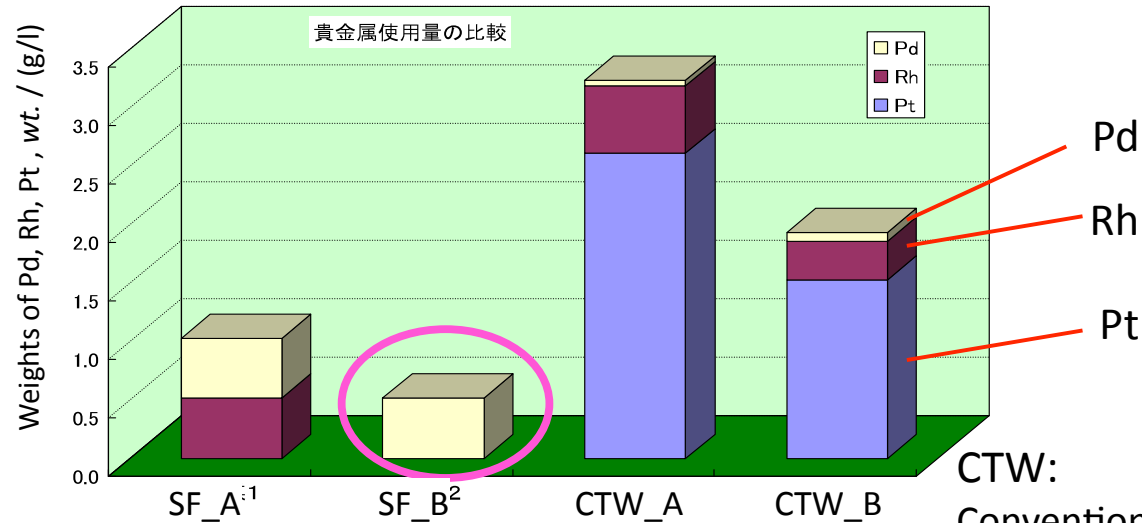


*In situ* observation of the catalyst during RedOx cycles



# Performance of the new catalyst

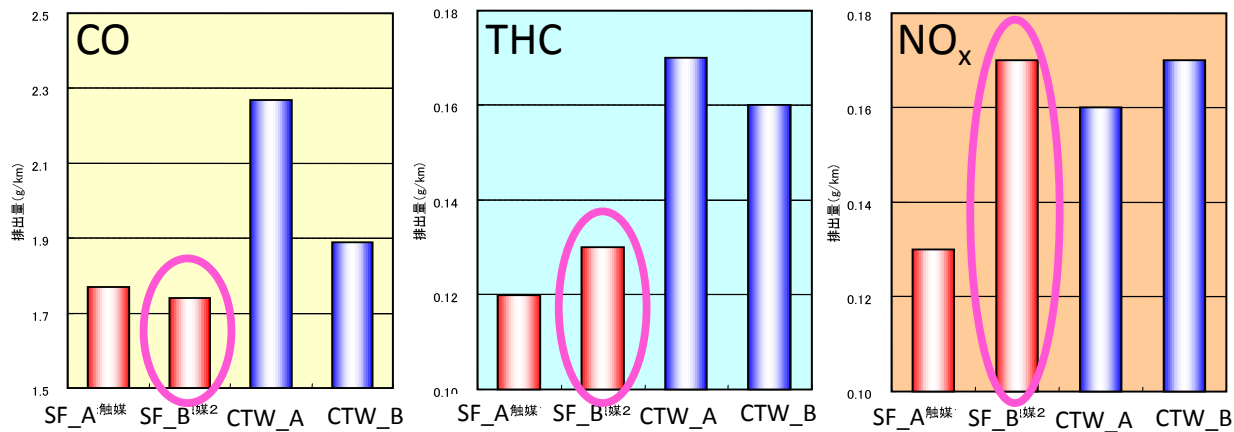
> Amounts of precious metals



SF:  
New catalysts  
(Pd,Rh)/Sr-Fe-O

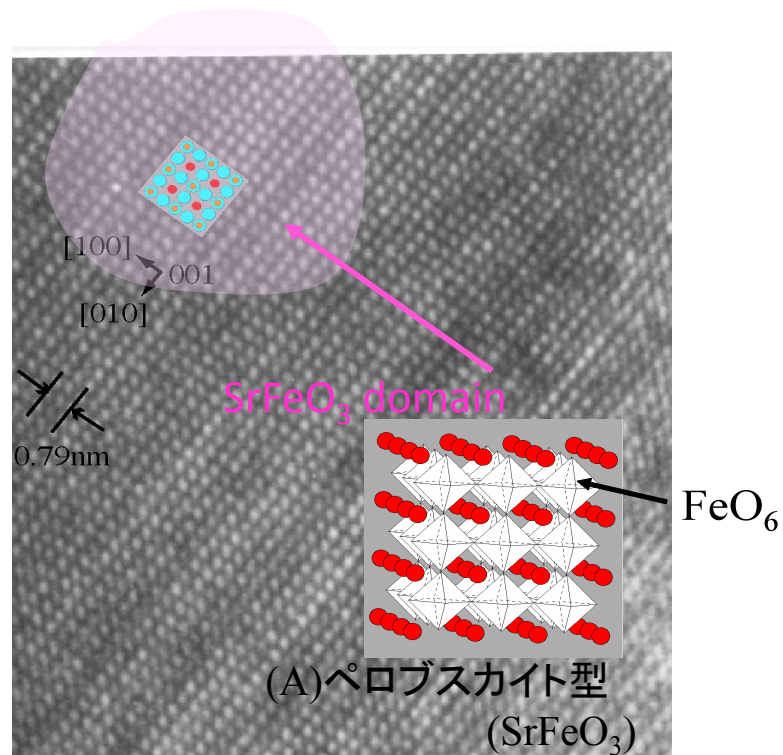
CTW:  
Conventional three-way catalysts  
(Pd,Rh,Pt)/(CeO<sub>2</sub>+ZrO<sub>2</sub>)

> Results of the performance test



# Microstructures of the Pd / Sr-Fe-O catalyst

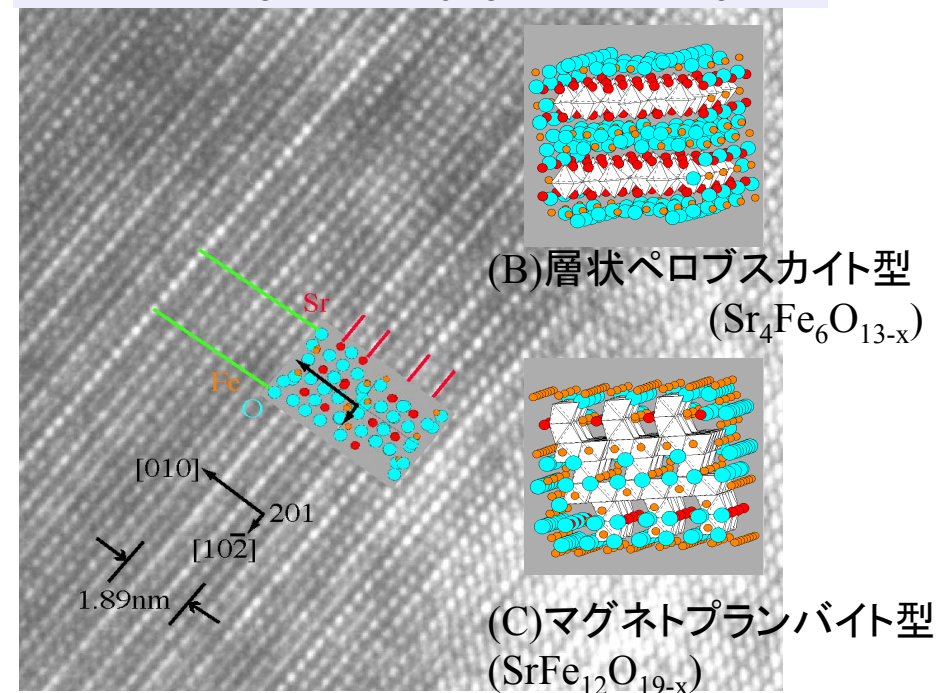
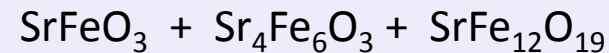
Unique structure of the oxide:  
“Multi-Phase Domain structures”



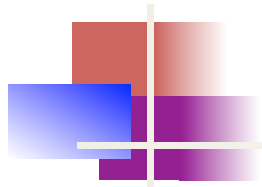
>Perovskite-type oxides

>The new catalyst showed an excellent performance of oxygen storage capacity (OSC) in 800 K < T < 1200 K

Other phases:







# Experiment

Sample: Pd/Sr-Fe-O (Pd 3wt%)

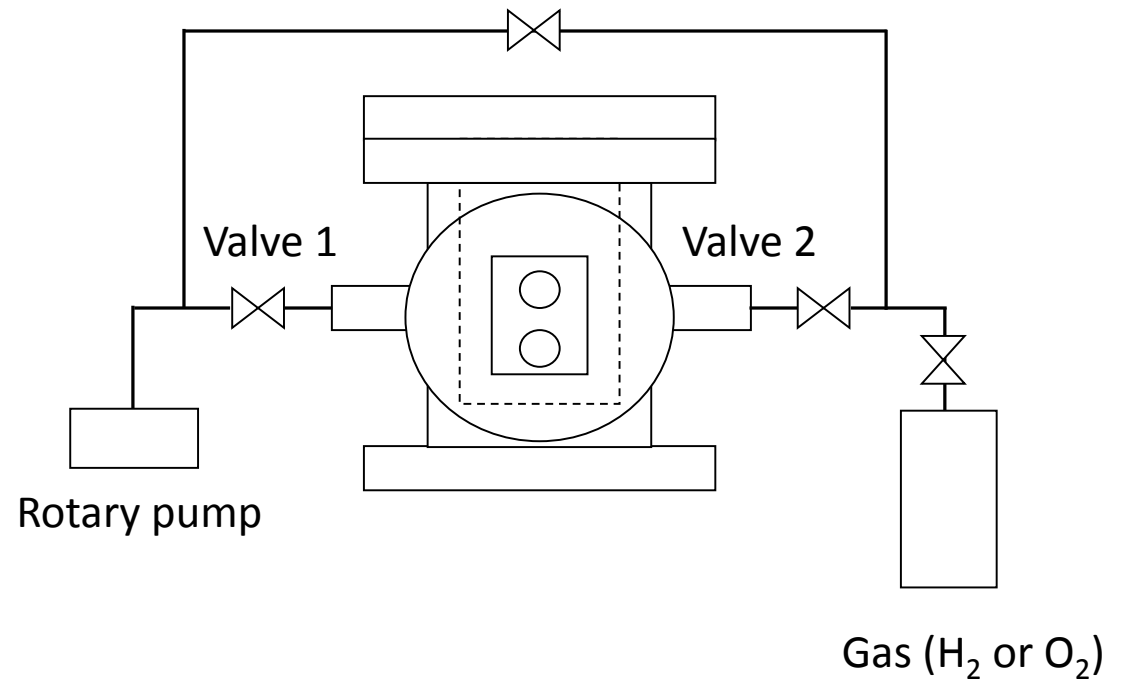
Reduction: H<sub>2</sub> (4.0 - 49.5 kPa)

Oxidation: O<sub>2</sub> (4.1 - 61.8 kPa)

Temp.: 673 K

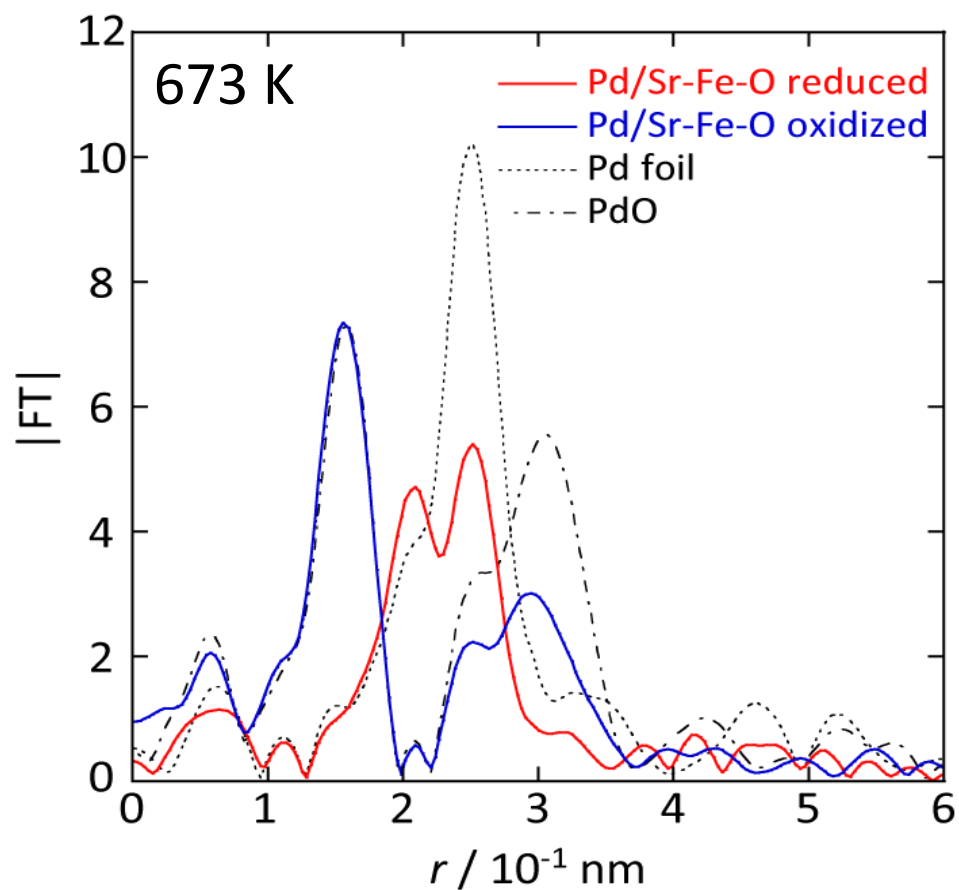
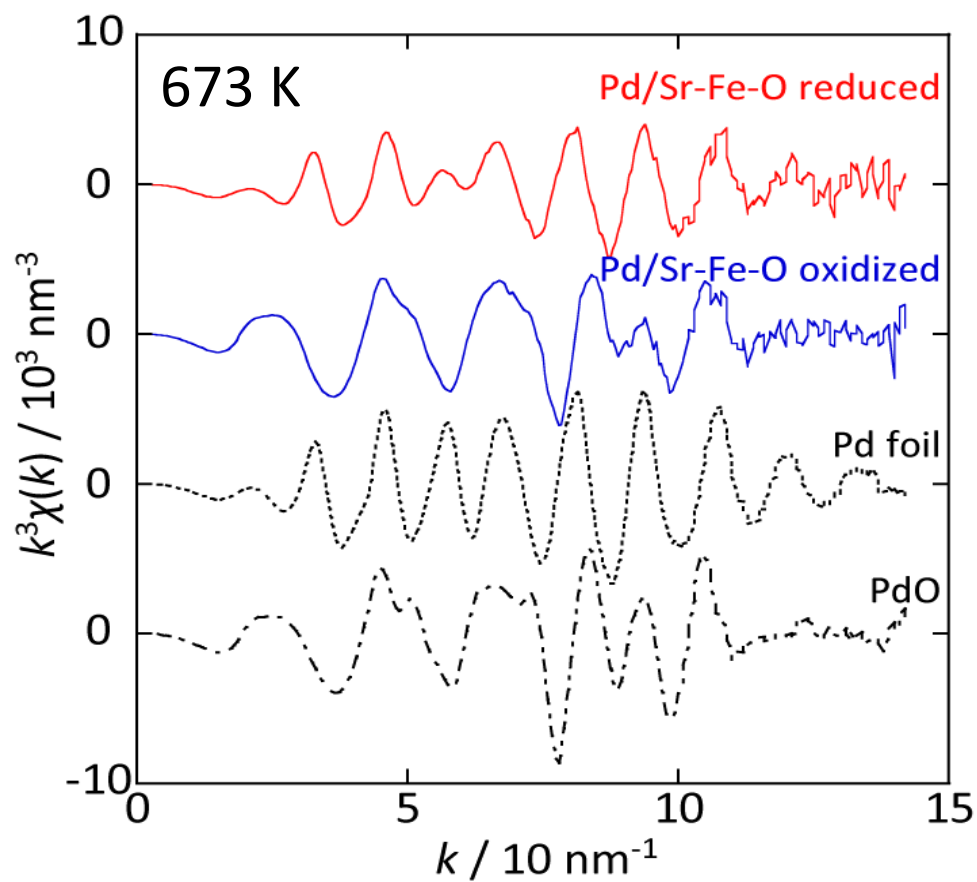


Cell for *in situ* experiment

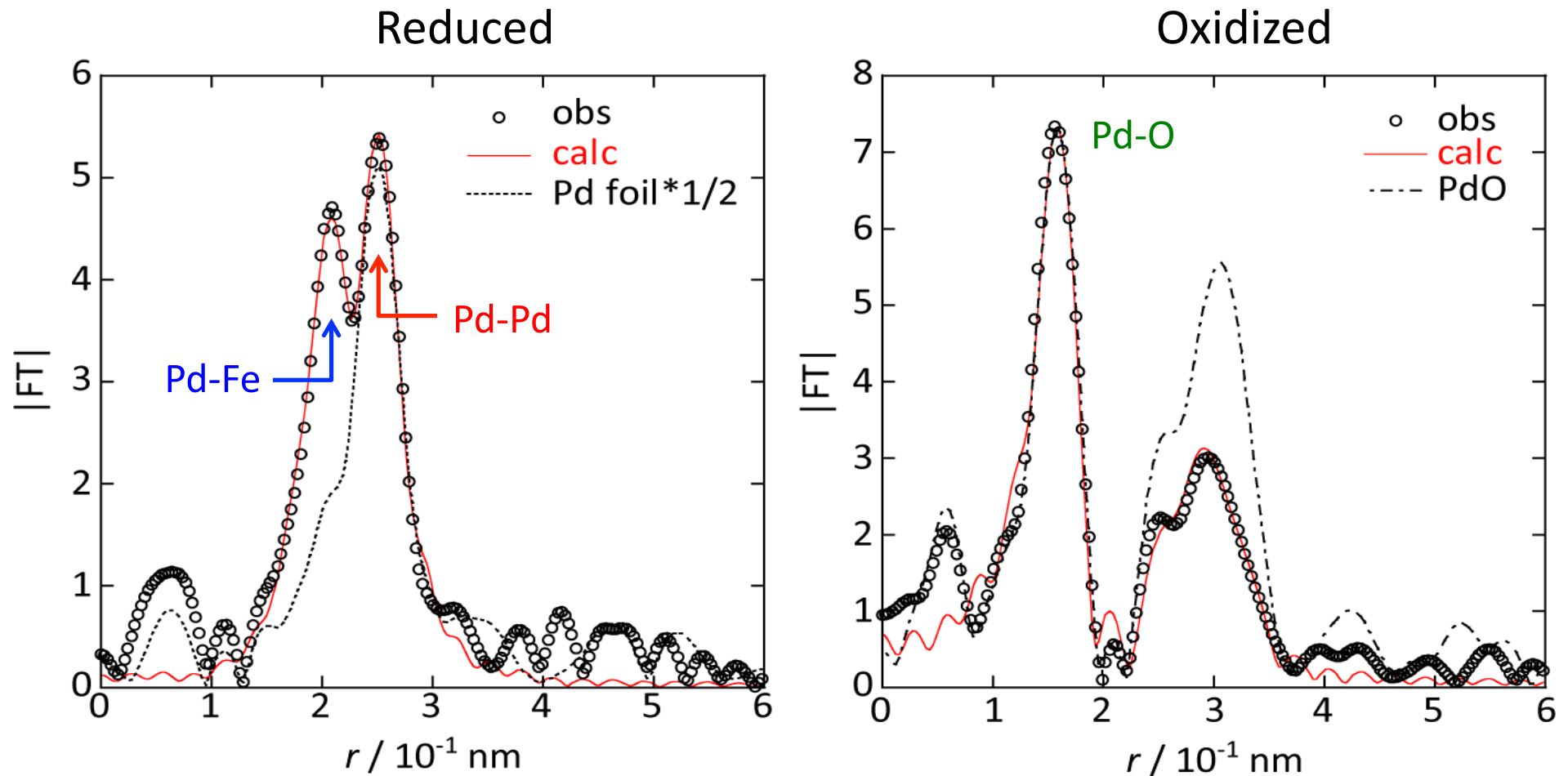




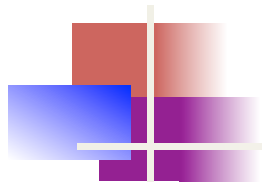
# Pd structures of reduced and oxidized states



# EXAFS fitting analyses with standards

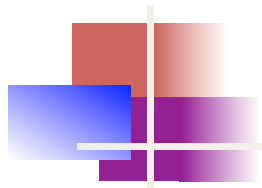


An interaction of Pd-Fe was considered.



## Structural parameters obtained by EXAFS analyses

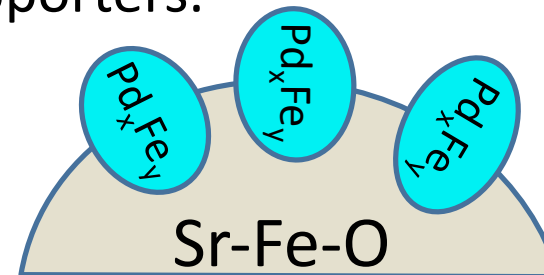
		Pd/Sr-Fe-O @673 K		Reference@673 K	
		Reduced	Oxidized	PdO	Pd foil
	$S_0^2$	0.968918 <sup>*2</sup>	1.018803 <sup>*1</sup>	1.018803 <sup>*1</sup>	0.968918 <sup>*2</sup>
Pd(II)-O	$N$		3.6	3.3	
	$r / 10^{-1} \text{ nm}$		2.02	2.03	
	$\sigma^2 / 10^{-2} \text{ nm}^2$		0.0055	0.0050	
	$\Delta E_0 / \text{ eV}$		12.87	13.92	
Pd(0)-Fe	$N$	1.5			
	$r / 10^{-1} \text{ nm}$	2.58			
	$\sigma^2 / 10^{-2} \text{ nm}^2$	0.0098			
	$\Delta E_0 / \text{ eV}$	-3.372			
Pd(0)-Pd(0)	$N$	5.6			10.2
	$r / 10^{-1} \text{ nm}$	2.72			2.73
	$\sigma^2 / 10^{-2} \text{ nm}^2$	0.013			0.012
	$\Delta E_0 / \text{ eV}$	2.10			3.26
Pd(II)-Pd(II)	$N$		1.7	3.3	
	$r / 10^{-1} \text{ nm}$		3.02	3.05	
	$\sigma^2 / 10^{-2} \text{ nm}^2$		0.0074	0.0084	
	$\Delta E_0 / \text{ eV}$		6.689	11.10	
Pd(II)-Pd(II)	$N$		3.6	5.6	
	$r / 10^{-1} \text{ nm}$		3.41	3.43	
	$\sigma^2 / 10^{-2} \text{ nm}^2$		0.010	0.0092	
	$\Delta E_0 / \text{ eV}$		8.640	10.54	
*fixed value					
<sup>1</sup> The value was determined by the fitting procedure for PdO at 298 K.					
<sup>2</sup> The value was determined by the fitting procedure for Pd foil at 298 K.					



# Pictures of the Pd catalysts

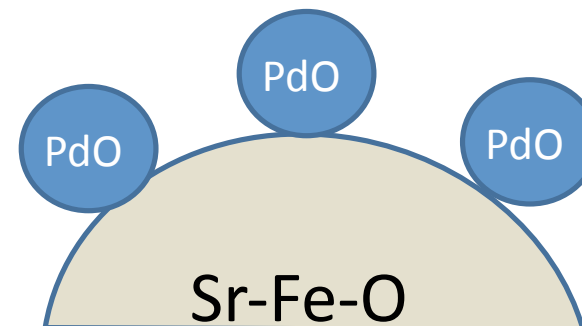
## Reduced state

Pd strongly interacts with Fe in the supporter. Alloys should be formed. They are in the form of clusters on the supporters.



## Oxidized state

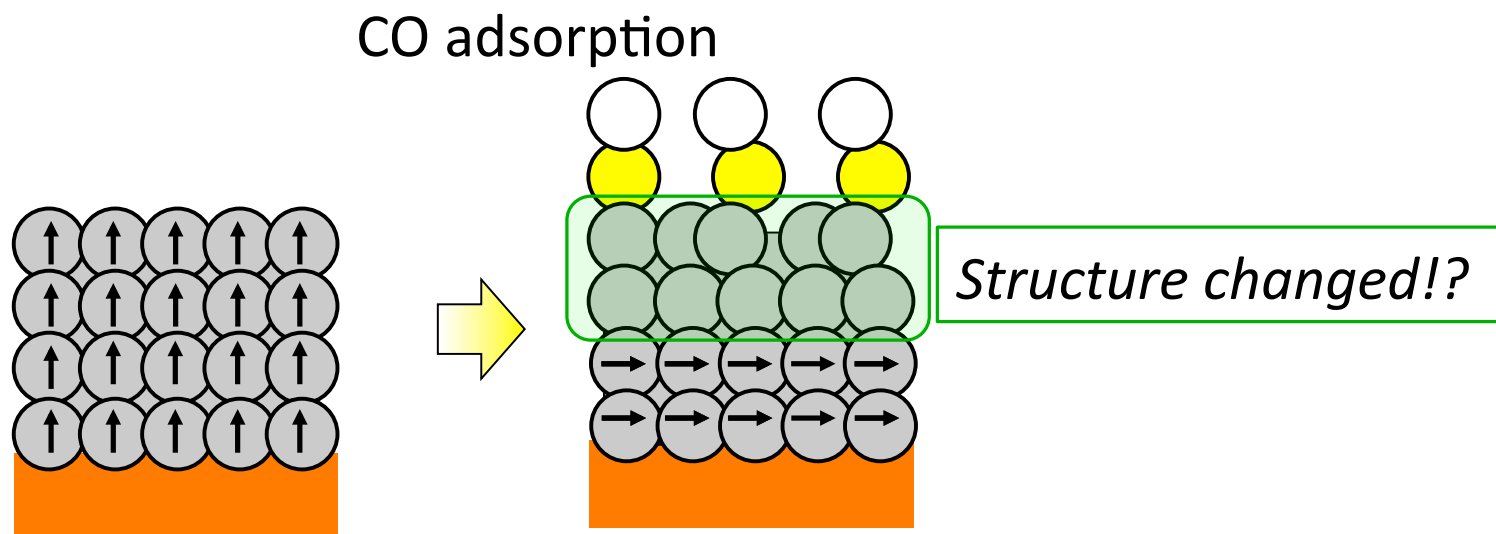
Pd are oxidized to PdO, and formed as clusters.



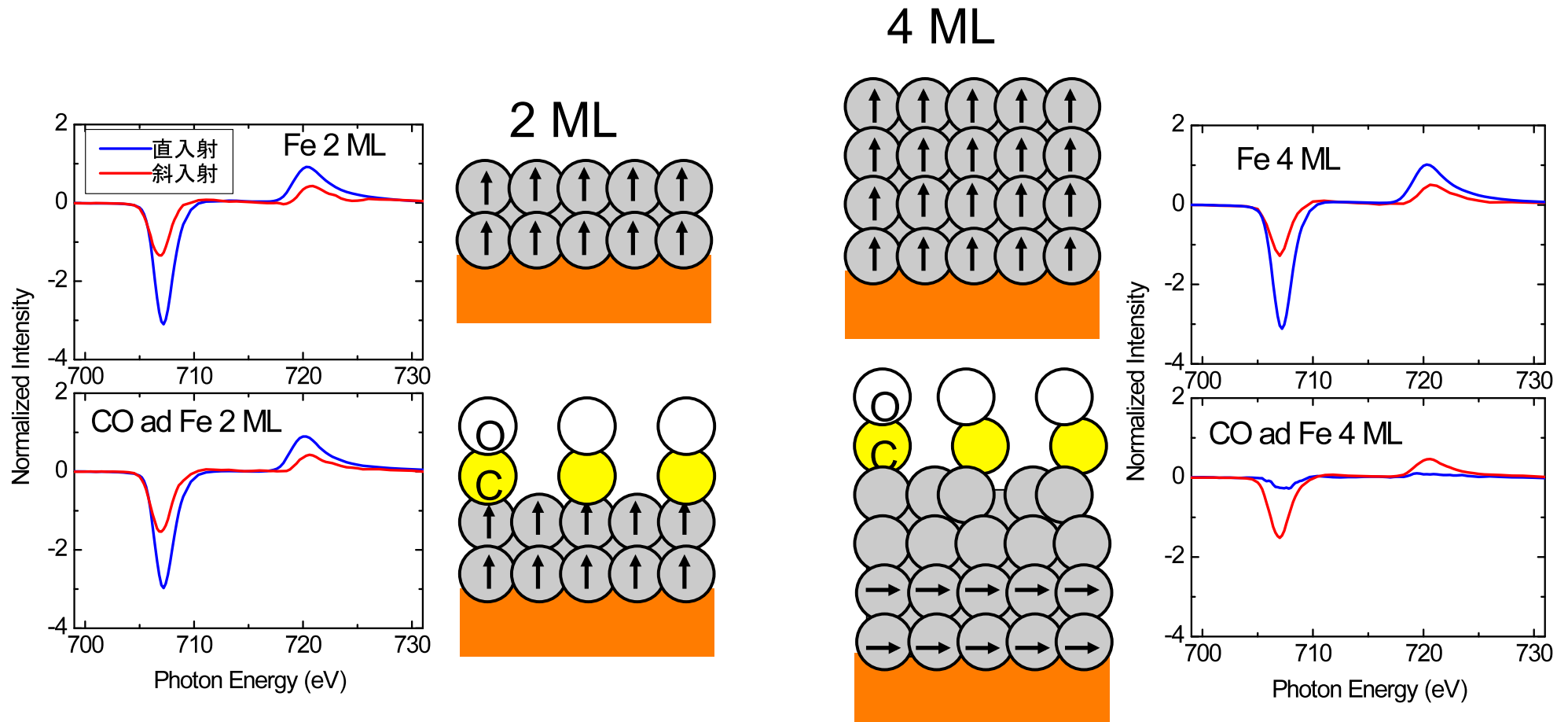
# EXAFS study of Magnetic thin films

CO adsorption on Fe(4 ML)/Cu(001) changes the magnetic structure of the film.

What's going on its structure?



# EXAFS experiment of magnetic thin films

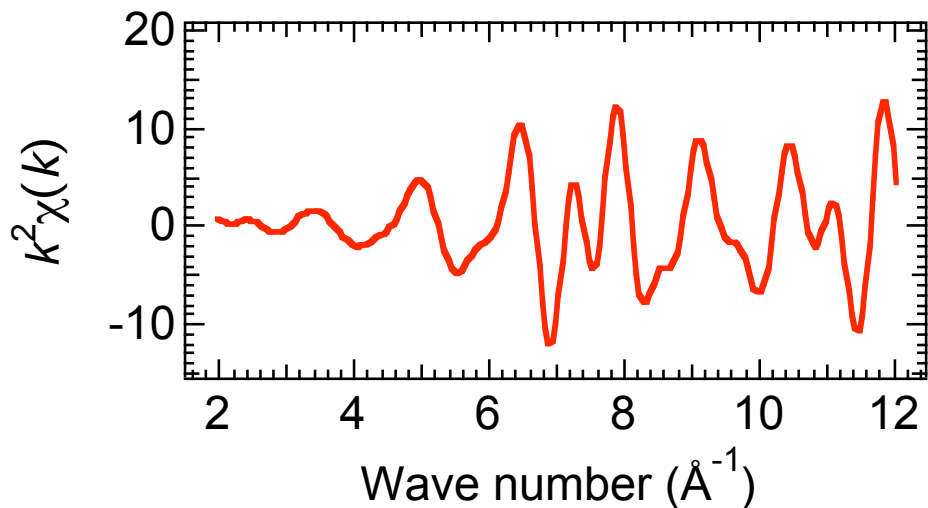


*A structural change of the surface!?*

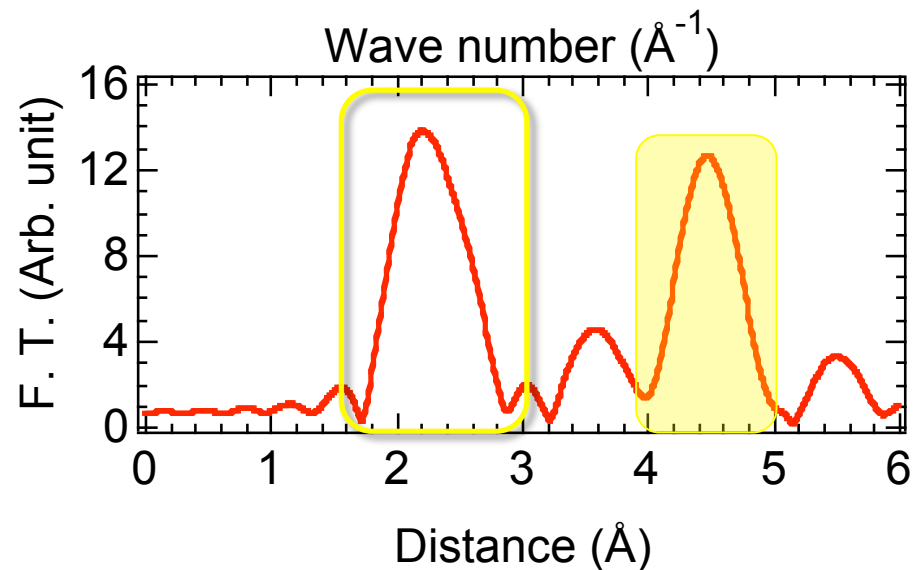
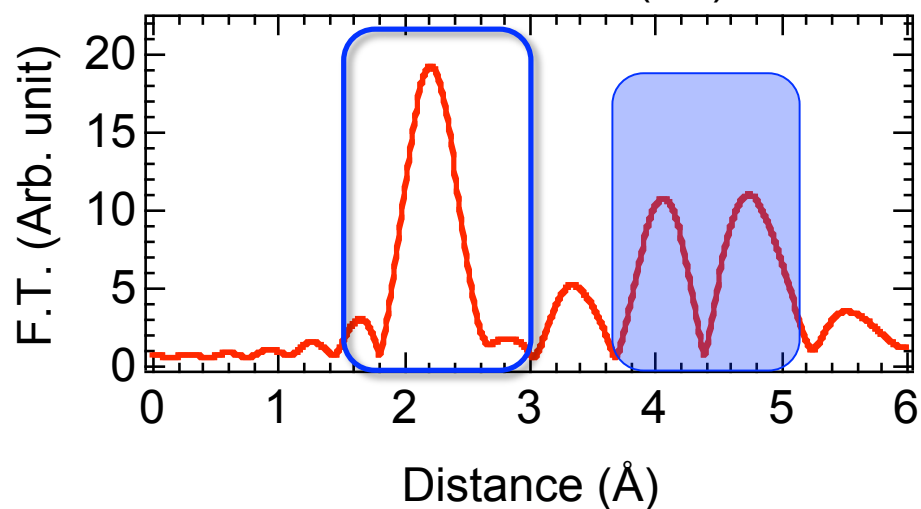
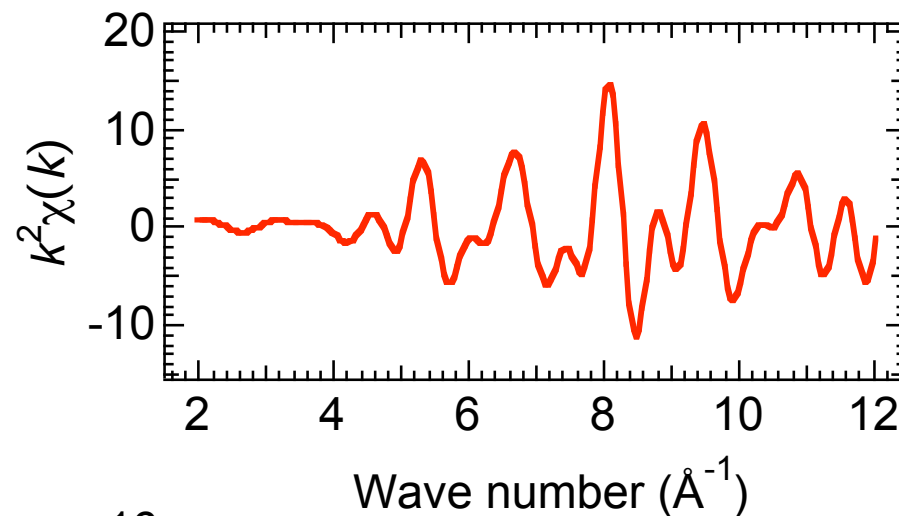
EXAFS experiment

# Fe-K EXAFS, FEFF simulation

fcc



bcc

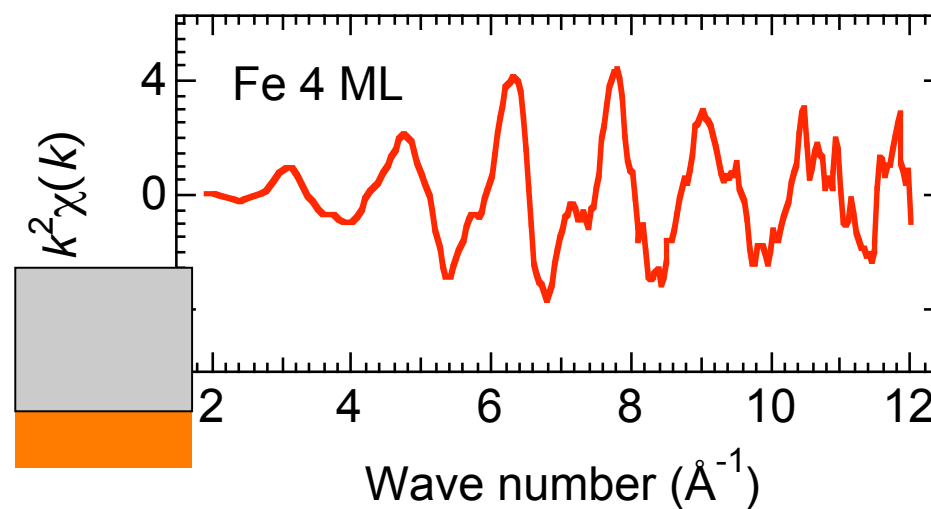
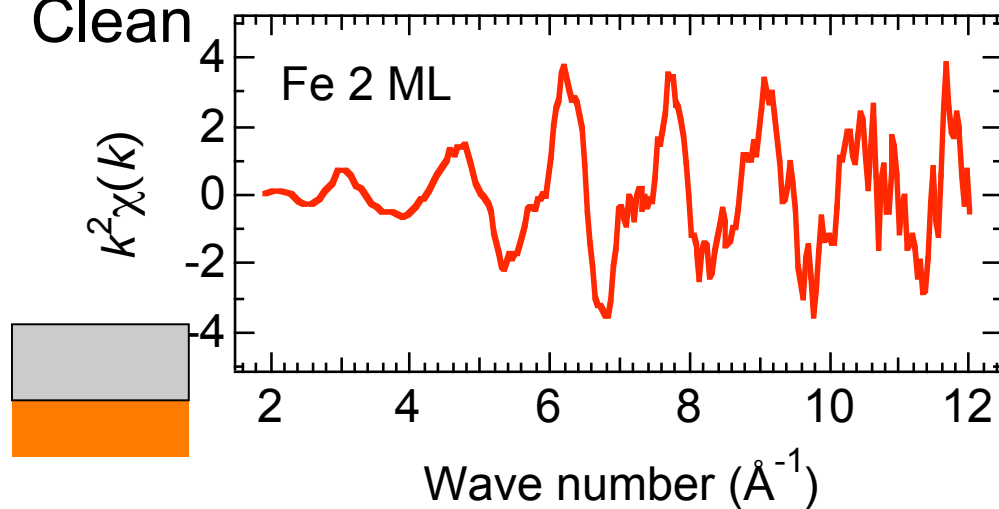


# Obtained EXAFS functions

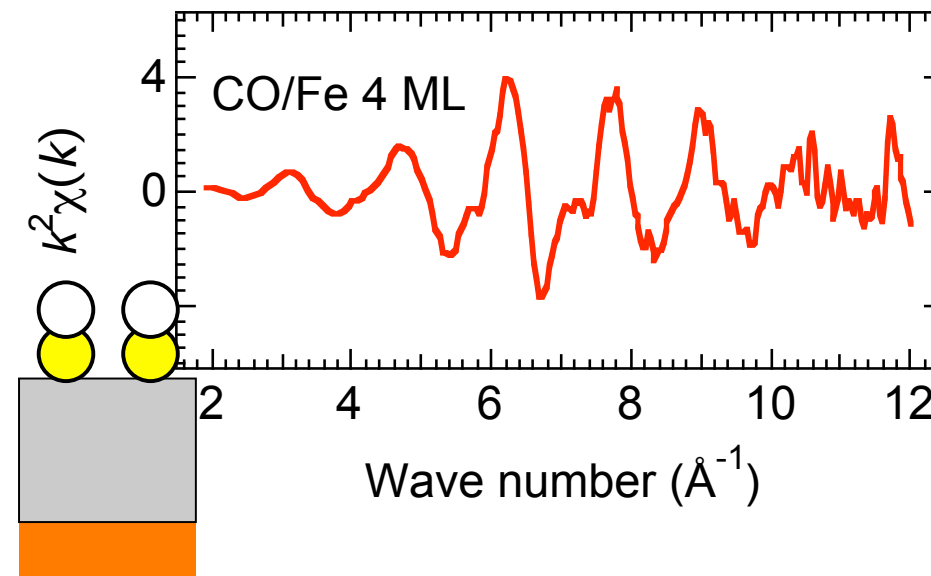
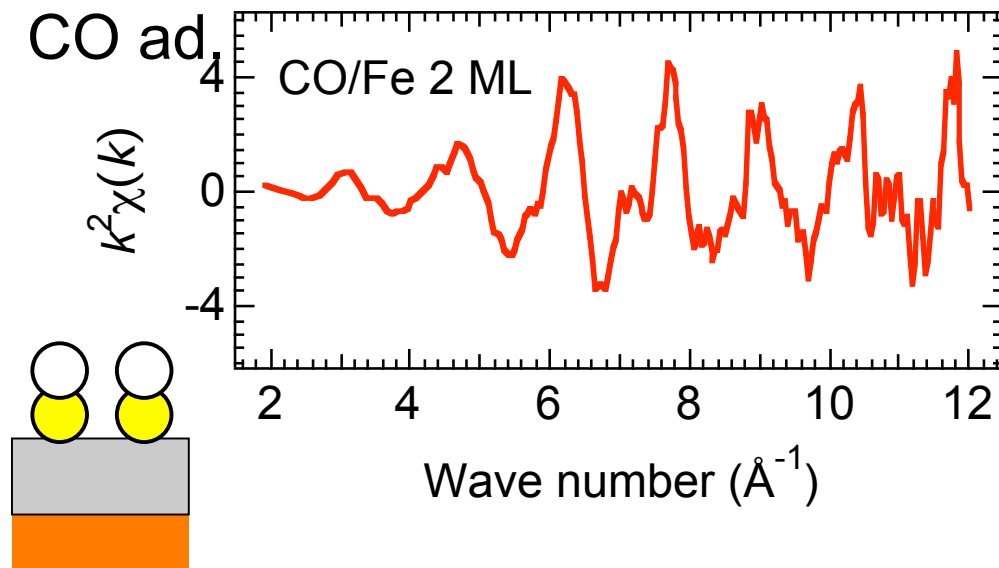
2 ML

4 ML

Clean

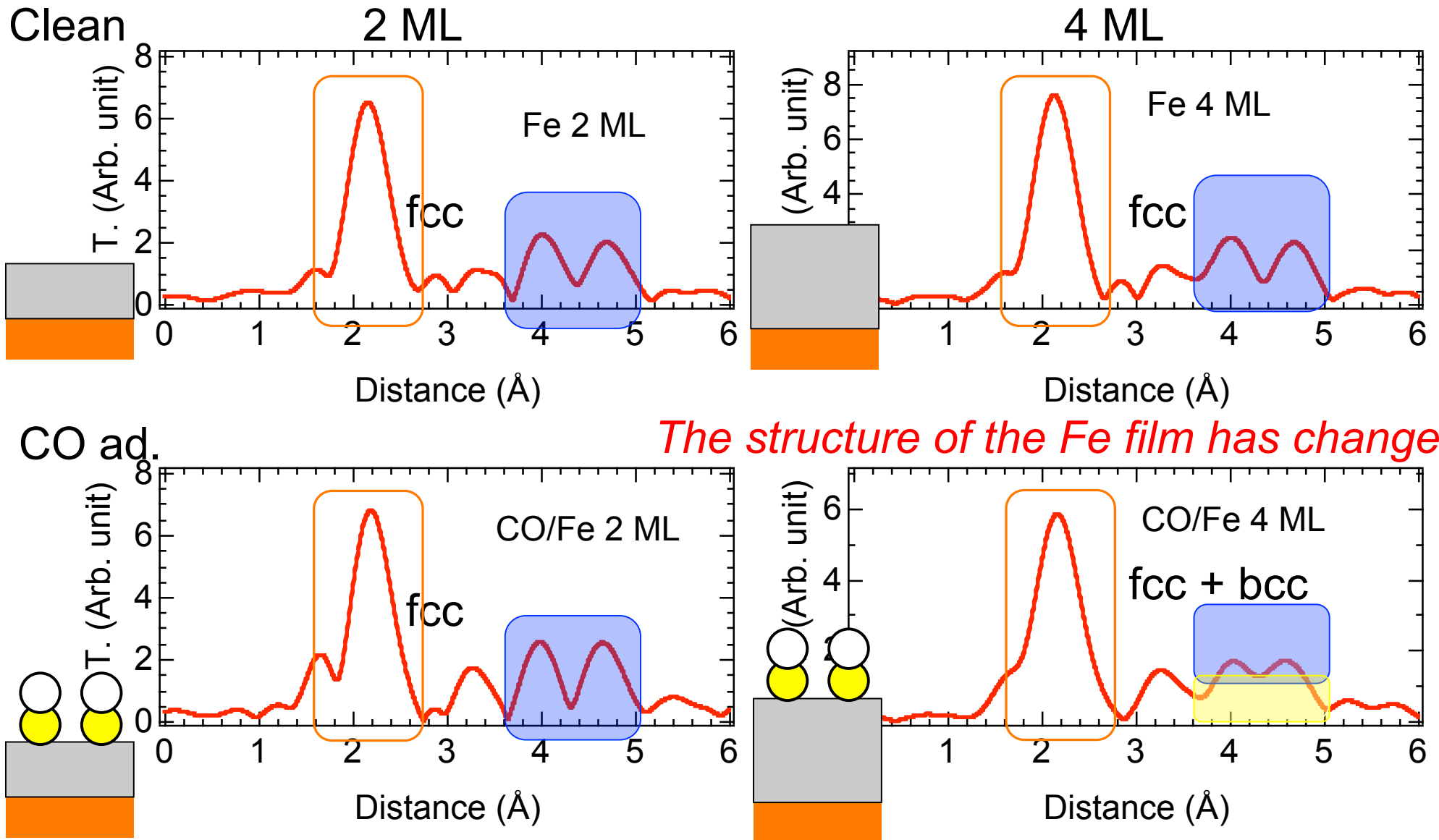


CO ad

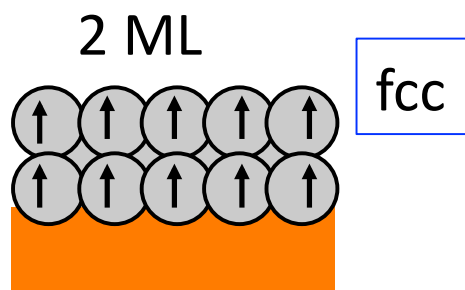




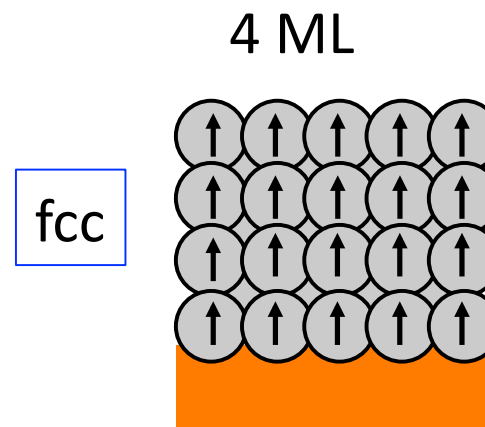
# Fourier Transforms of $\chi(k)$



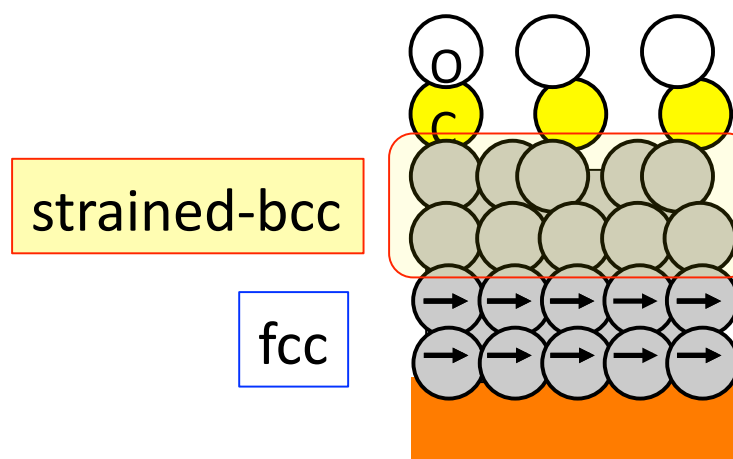
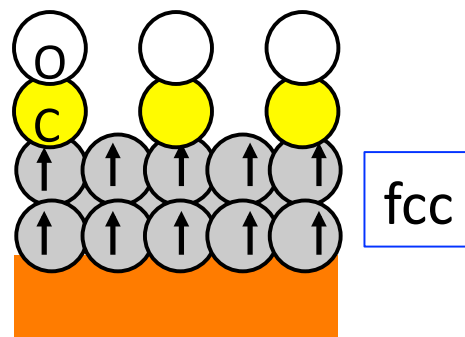
# Possible model of structures of the films



*Before CO ad. : fcc*



*Changed to be fcc + strained-bcc*



# Take-home message

## XAFS : XANES + EXAFS

- XANES gives us...

- Valence state
- Symmetry

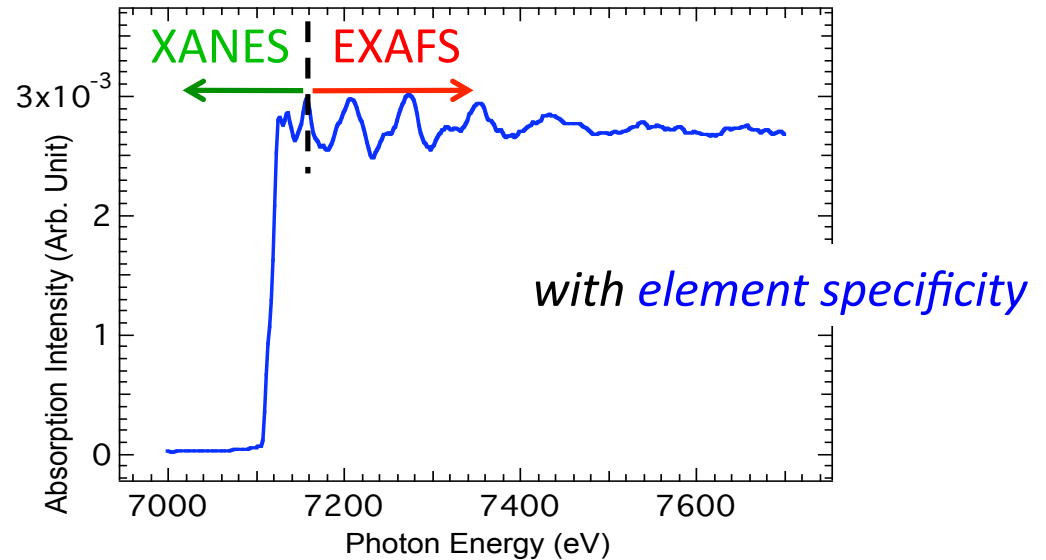
- EXAFS gives us...

- Bond length

- A local structure is given.
- Crystallinity, or long range order is not required.

- Coordination number (CN)

- Simply, the number of atoms around the atom.
- CN enables us to estimate sizes of nano clusters.



*The ruler is de Broglie wave of electron!!*

Thank you for your attention

